



UNIVERSITÀ DEGLI STUDI DI MILANO  
DIPARTIMENTO DI FISICA  
Rivelatori di Particelle – Prof. A. Andreazza

Tracking systems

# Sistemi traccianti: indice

- Lezione 1, 31/05: generalità sulle misure di posizione e momento
- Lezione 2, 05/06: sistemi di rivelatori, pattern recognition e track fit
- Esercitazioni pratiche (opzionali)
  - 14,16/06 alle 14 in Laboratorio Calcolo:  
simulazione di un rivelatore tracciante
- Appendice delle lezioni sui rivelatori a semiconduttore:  
12/06 Seminario rivelatori CMOS (E. Zaffaroni)

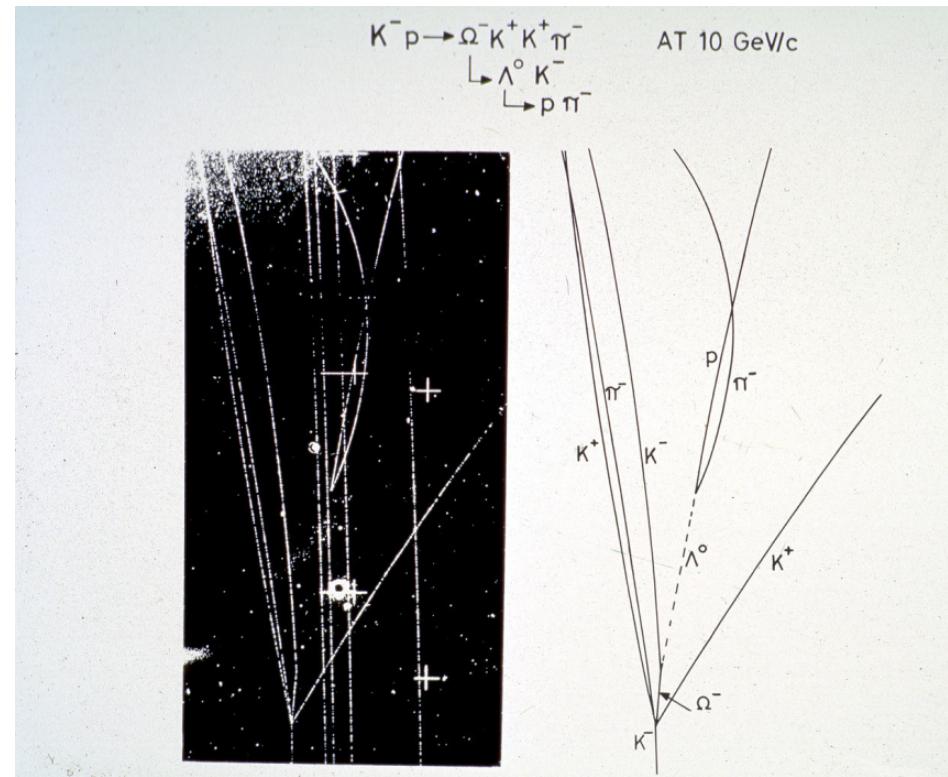


1. *What is the purpose of a tracking system*
2. *Helical trajectory and its approximations*
3. *Position measurements*
  1. intrinsic resolution
  2. multiple scattering effects
  3. vertex reconstruction
4. *Momentum measurements*
  1. intrinsic resolution
  2. multiple scattering effects

# GENERALITY OF POSITION AND MOMENTUM MEASUREMENTS

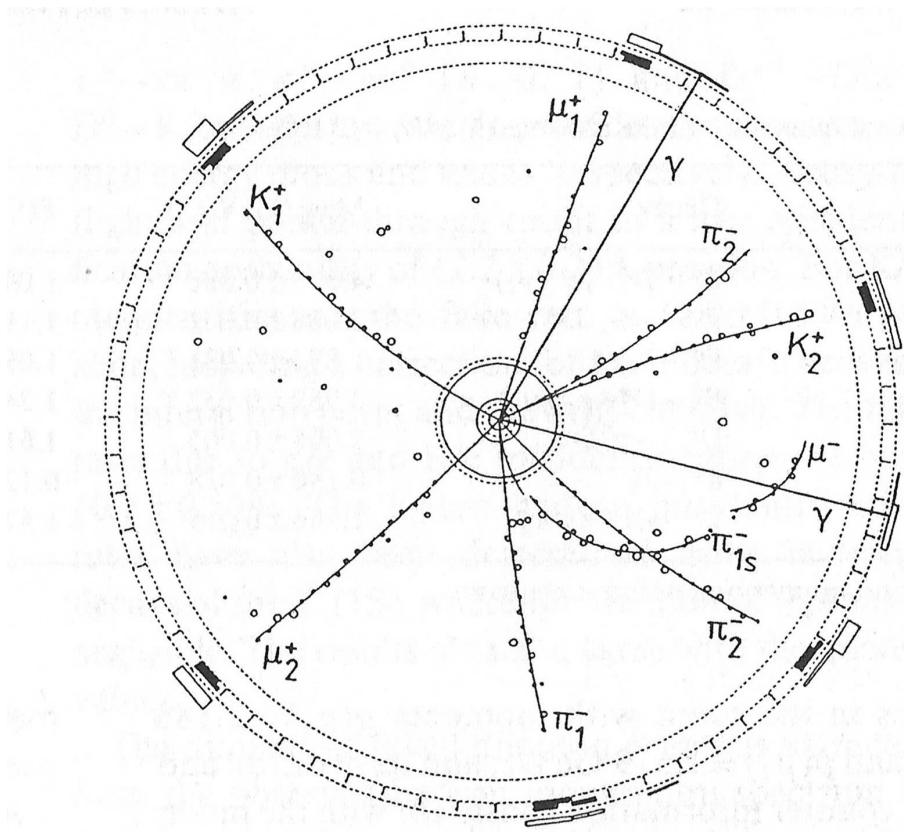
# The legacy of visual detectors

- Many progress in particle physics by looking at events:
  - find particle trajectories,
  - find where they interact
  - find where they decay



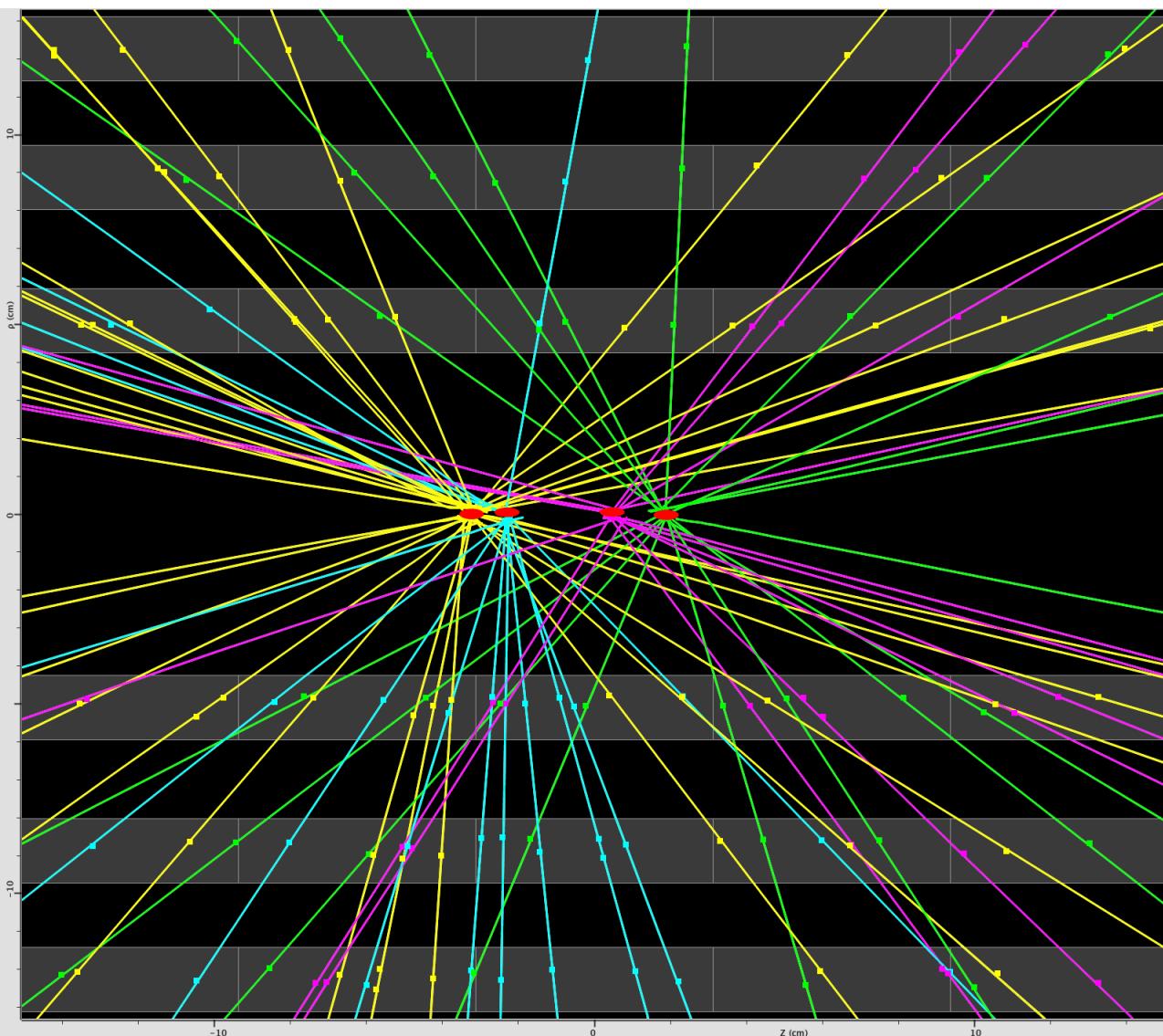
# The legacy of visual detectors

- Many progress in particle physics by looking at events:
  - find particle trajectories,
  - find where they interact
  - find where they decay
- Nothing has changed when moving to fully electronics readout
  - but density of measurements...
- Tracking is all about building **an image** of the particle interactions with **few observed points**.



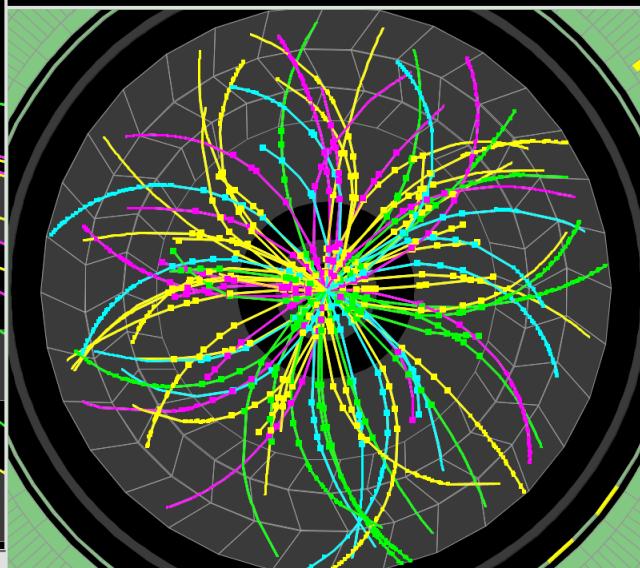
- 1)  $B_1^0 \rightarrow D_1^{*-} \mu_1^+ \nu_1, D_1^{*-} \rightarrow \pi_1^- \bar{D}^0, \bar{D}^0 \rightarrow K_1^+ \pi_1^-$
- 2)  $B_2^0 \rightarrow D_2^{*-} \mu_2^+ \nu_2, D_2^{*-} \rightarrow \pi^0 D^-, D^- \rightarrow K_2^+ \pi_2^- \pi_2^-$

# ATLAS event (low pile-up)

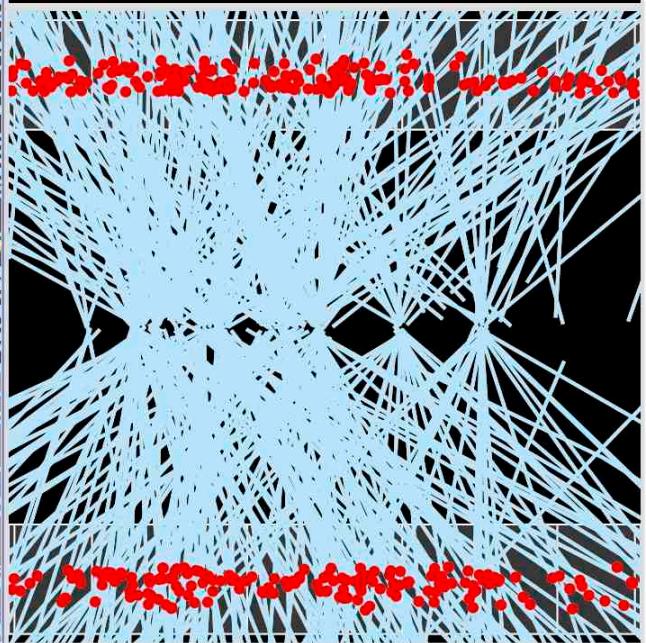
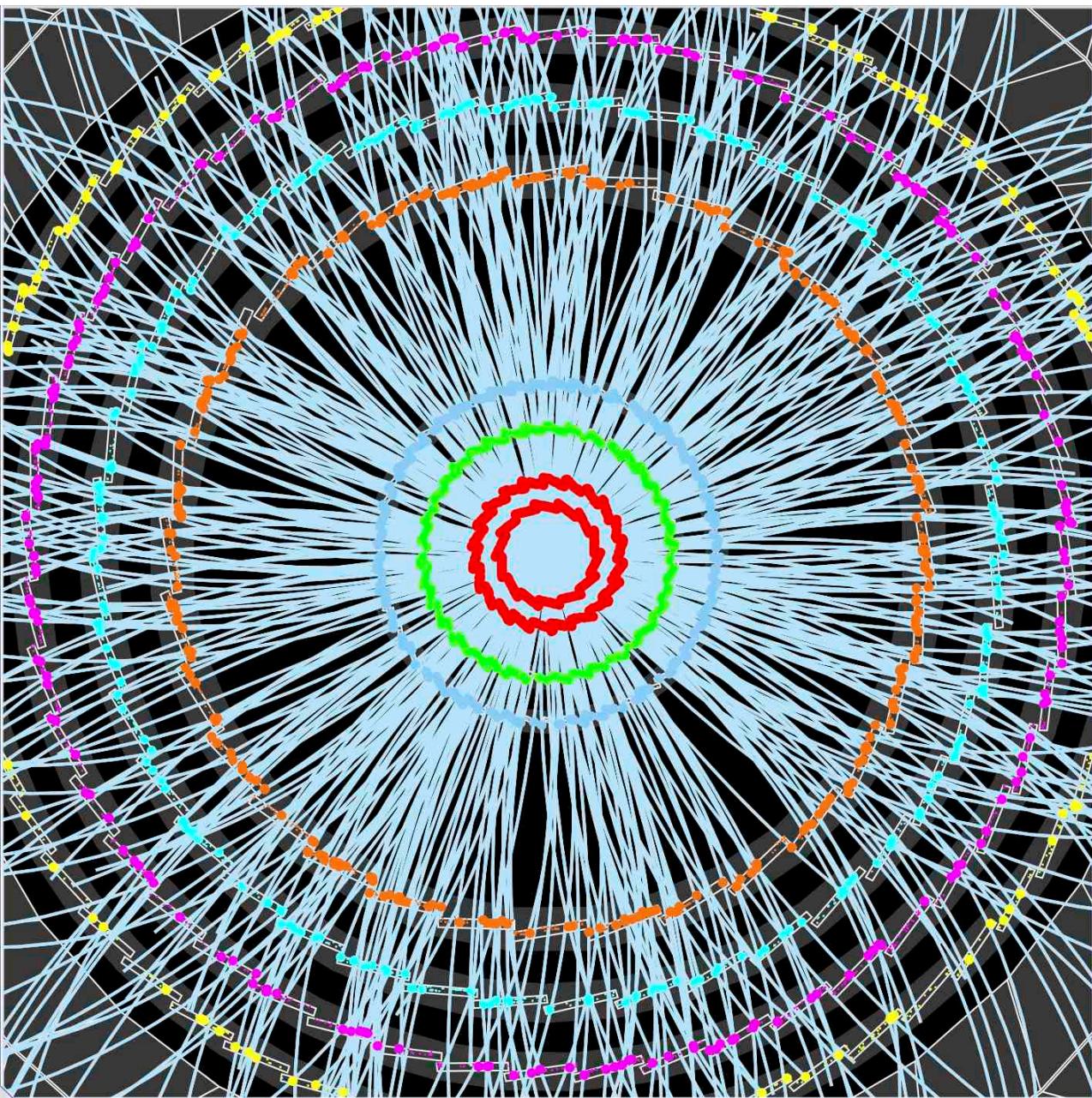


Run Number: 153565, Event Number: 4487360  
Date: 2010-04-24 04:18:53 CEST

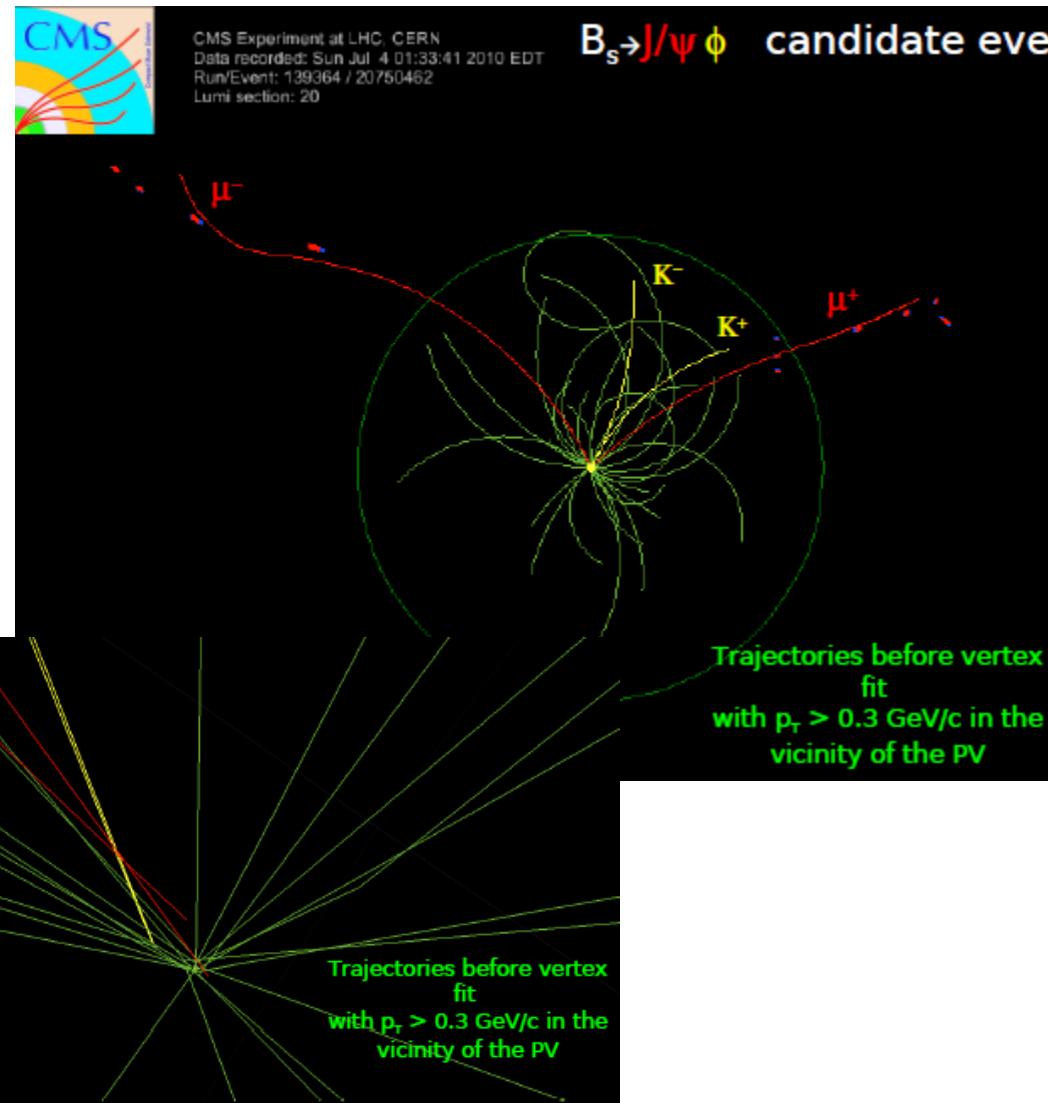
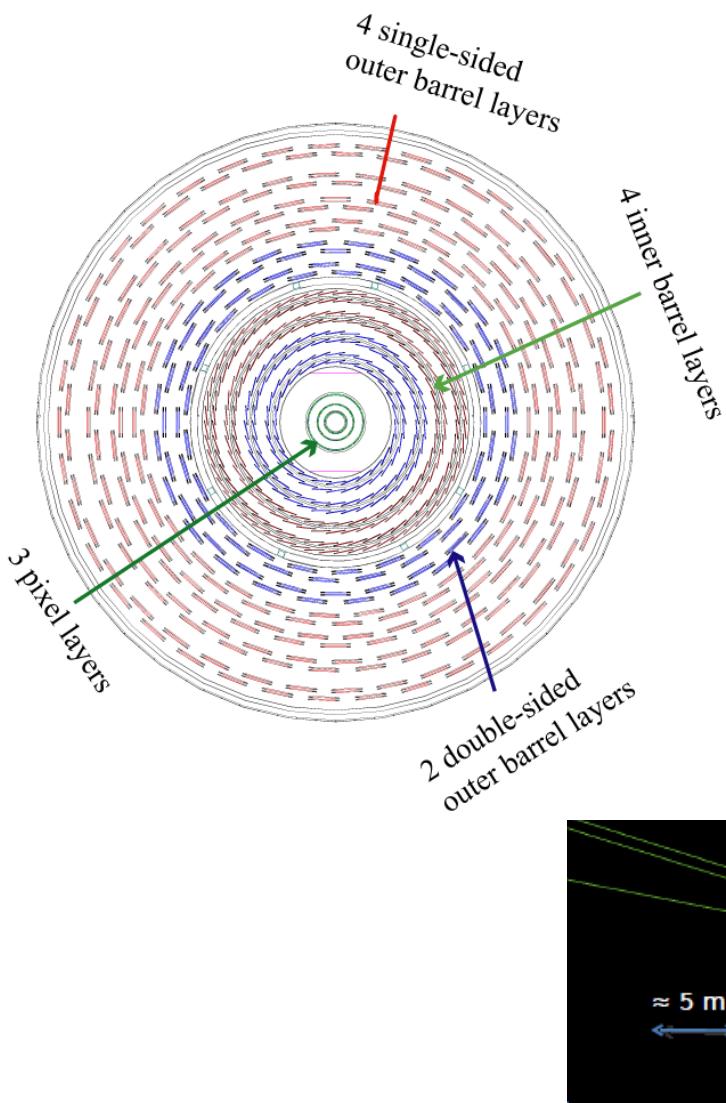
Event with 4 Pileup Vertices  
in 7 TeV Collisions



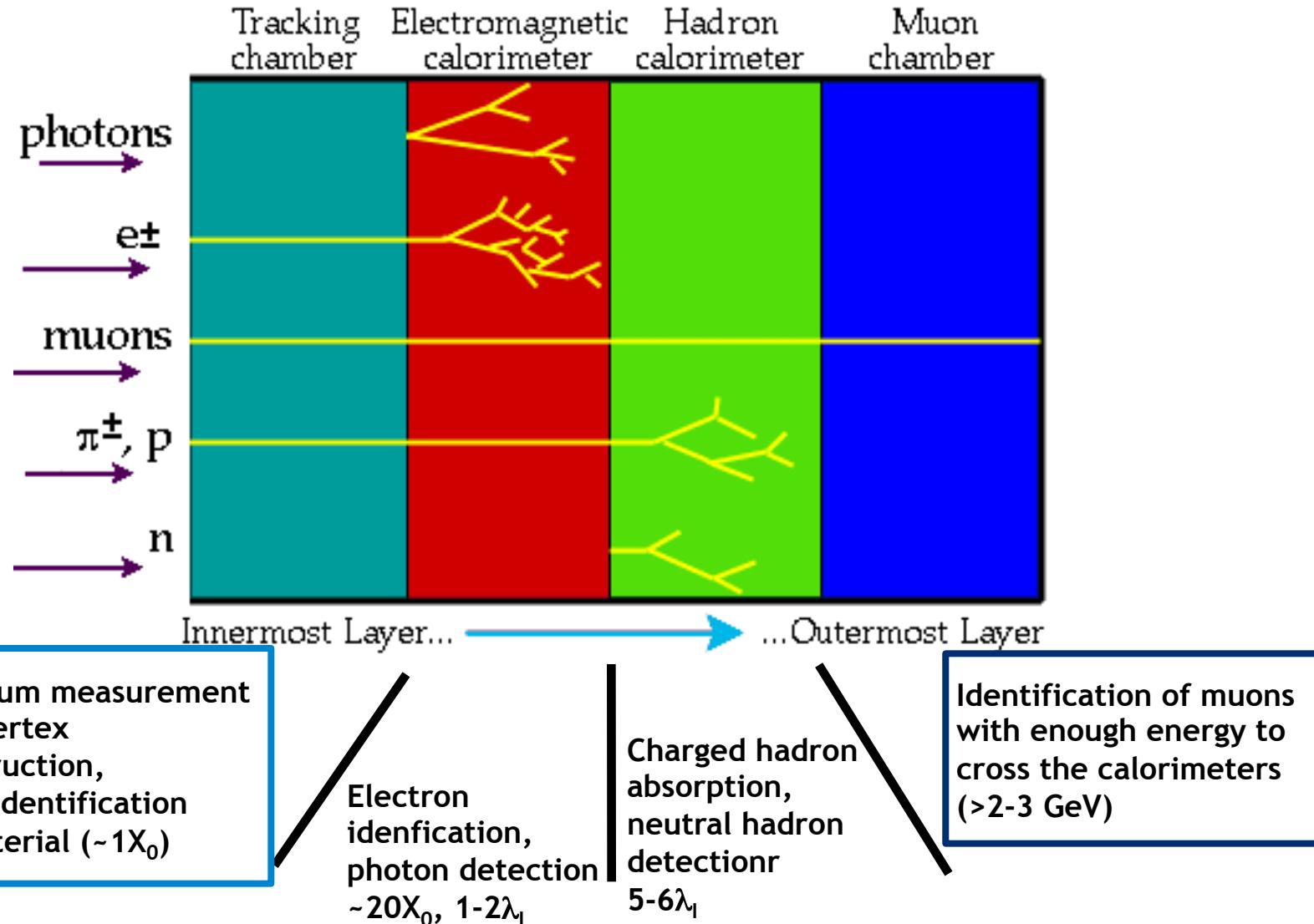
# ATLAS event at $\sqrt{s}=13$ TeV



# CMS event



# Particle detector structure



# Tracking system goals

## 1. Reconstruct charged-particle trajectories (tracks)

- join points to form a track (pattern recognition)
- measure direction and position
- measure momentum and charge (with magnetic field)
- Two major configurations:
  - inner spectrometers
  - muon systems

## 2. Reconstruct decay and interaction vertices

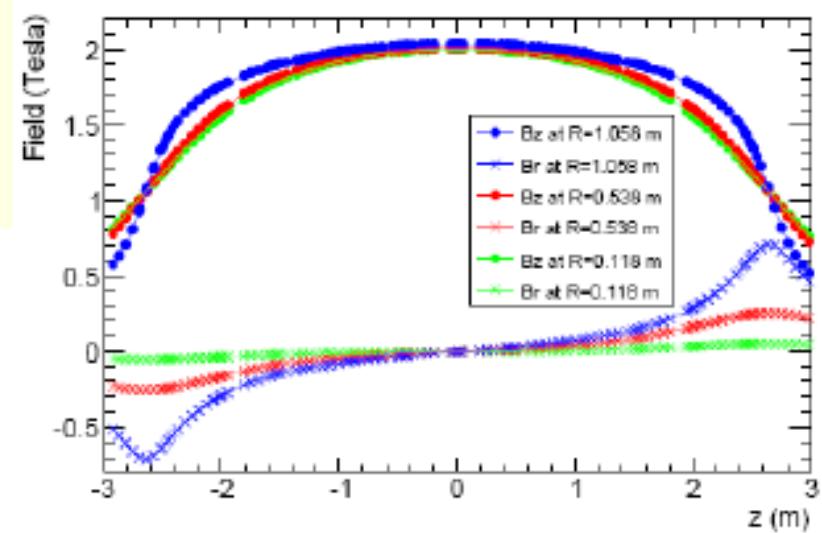
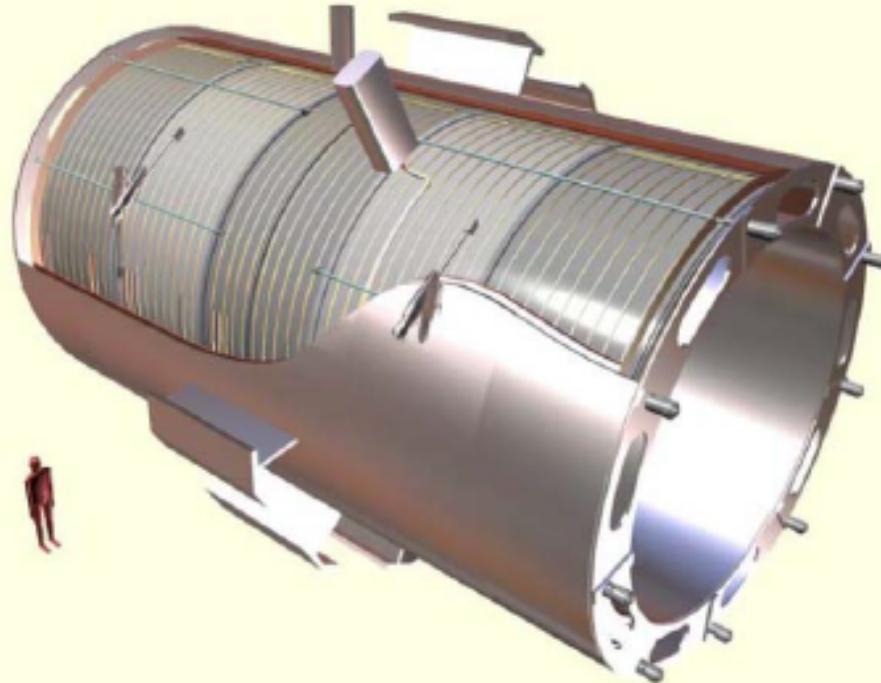
- “primary” vertex: collision point where most particle are produced
- “secondary” vertices:
  - decay of unstable particles
  - interaction with detector material
- evaluate compatibility of tracks with primary vertex
  - “weaker” way to detect interaction or unstable particles.



# THE HELIX AND ITS APPROXIMATIONS



# Superconducting magnets



Tracking systems are usually embedded in a magnetic field in order to measure particle momentum through curvature

- typical values 0.5-4 T
- solenoid, toroid, dipole configurations all used

# Motion in a magnetic field

- The equation of motion of a charged particle in a magnetic field is:

$$\frac{d\mathbf{p}}{dt} = e\mathbf{v} \times \mathbf{B}$$

- The relativistic formula for the momentum is  $pc = \epsilon v/c$  with
  - $\epsilon$  particle energy
  - $v$  particle velocity

- The equation of motion becomes:

$$\frac{d\mathbf{p}}{dt} = \frac{1}{c^2} \frac{d\epsilon}{dt} \mathbf{v} + \frac{\epsilon}{c^2} \frac{d\mathbf{v}}{dt} = e\mathbf{v} \times \mathbf{B}$$

- multiplying by  $v$  ( $v$  is perpendicular to both  $d\mathbf{v}$  and  $\mathbf{v} \times \mathbf{B}$ )

$$\frac{d\epsilon}{dt} = 0$$

- This is the well-known feature the magnetic field does not perform work on the particle: energy is a constant of motion.

- The final equation of motions is:

$$\frac{d\mathbf{v}}{dt} = \mathbf{v} \times \Omega_v, \quad \Omega_v = \frac{e\mathbf{B}}{\epsilon} c^2$$

- linear velocity precess with angular velocity  $\Omega_v$
- if  $v$  is normal to  $B$  the trajectory is a circumference with a revolution period  $T = 2\pi/\Omega_v$ 
  - in the non-relativistic case:  $T = \text{const.}$
  - in the relativistic case:  $T \propto \gamma$
- To find the circumference radius:

$$\frac{2\pi R}{T} = v \rightarrow R = \frac{vT}{2\pi} = \frac{v}{\Omega_v}$$

$$R = \frac{v\epsilon}{eBc^2} \quad \beta\epsilon = pc \quad R = \frac{p}{eB}$$

- giving momentum in GeV, the radius in meters and magnetif field in Tesla

$$p = 0.299792458 RB \implies p = 0.3 RB$$



# Motion in a magnetic field

- The equation of motion of a charged particle in a magnetic field is:

$$\frac{d\mathbf{p}}{dt} = e\mathbf{v} \times \mathbf{B}$$

- Since the B field does not change the energy of the particle:

$$m\gamma \frac{d\mathbf{v}}{dt} = e\mathbf{v} \times \mathbf{B}$$

$$m\gamma \frac{d^2\mathbf{r}}{dt^2} = e \frac{d\mathbf{r}}{dt} \times \mathbf{B}$$

- Using the length along the path

$$ds = v dt$$

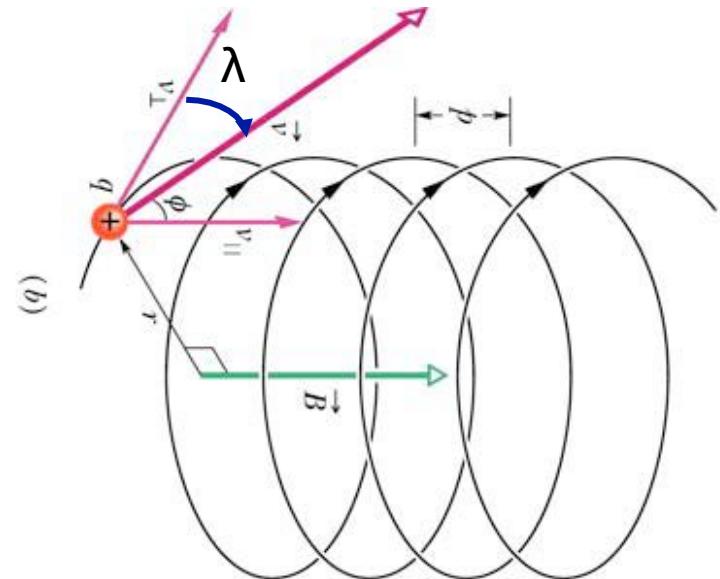
- One obtains:

$$m\gamma v \frac{d^2\mathbf{r}}{ds^2} = e \frac{d\mathbf{r}}{ds} \times \mathbf{B}$$

- Finally

$$\frac{d^2\mathbf{r}}{ds^2} = \frac{e}{p} \frac{d\mathbf{r}}{ds} \times \mathbf{B}$$

- In case of inhomogeneous magnetic field  $\mathbf{B}(s)$  varies along the track, and to find the trajectory  $\mathbf{r}(s)$  one needs to solve numerically the differential equation.
- In case of homogeneous magnetic field, the trajectory is given by an helix.



# The helix equation

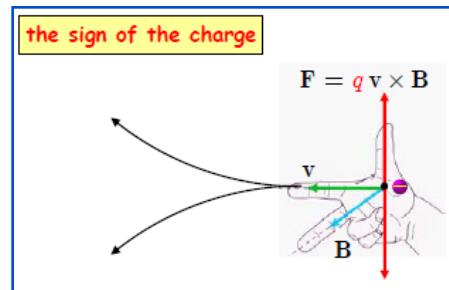
- The helix can be described in a parametric form

$$x(s) = x_0 + R \left[ \cos\left(\Phi_0 + \frac{hs \cos \lambda}{R}\right) - \cos \Phi_0 \right]$$

$$y(s) = y_0 + R \left[ \sin\left(\Phi_0 + \frac{hs \cos \lambda}{R}\right) - \sin \Phi_0 \right]$$

$$z(s) = z_0 + s \sin \lambda$$

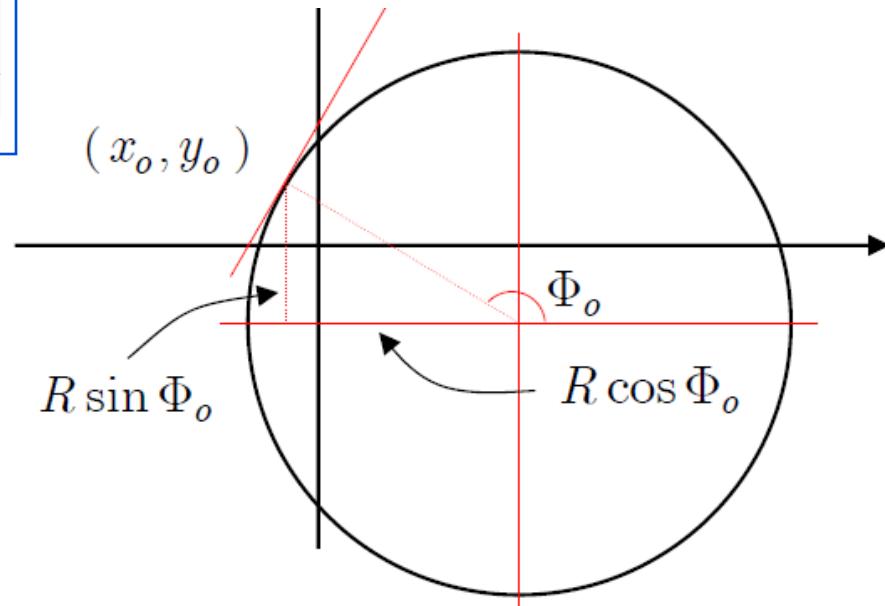
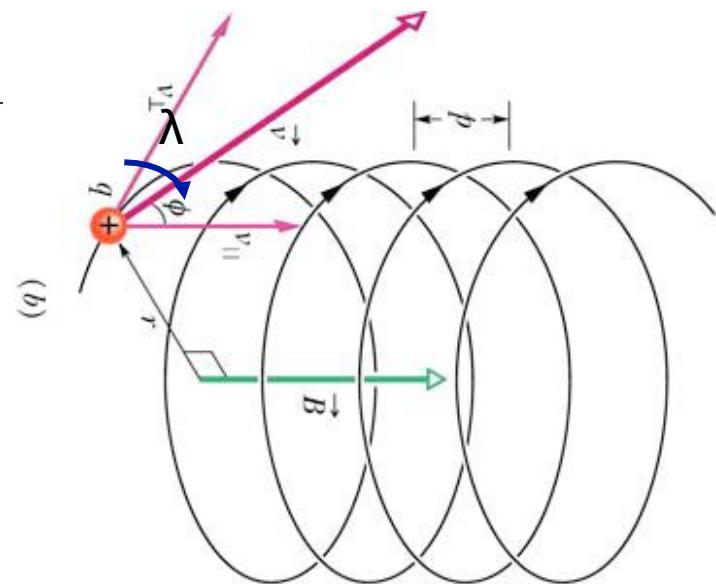
- $\lambda$  is the dip-angle
- $h=\pm 1$  is the sense of rotation of the helix



- The projection on the  $xy$ -plane is a circle:

$$(x - x_0 + R \cos \Phi_0)^2 + (y - y_0 + R \sin \Phi_0)^2 = R^2$$

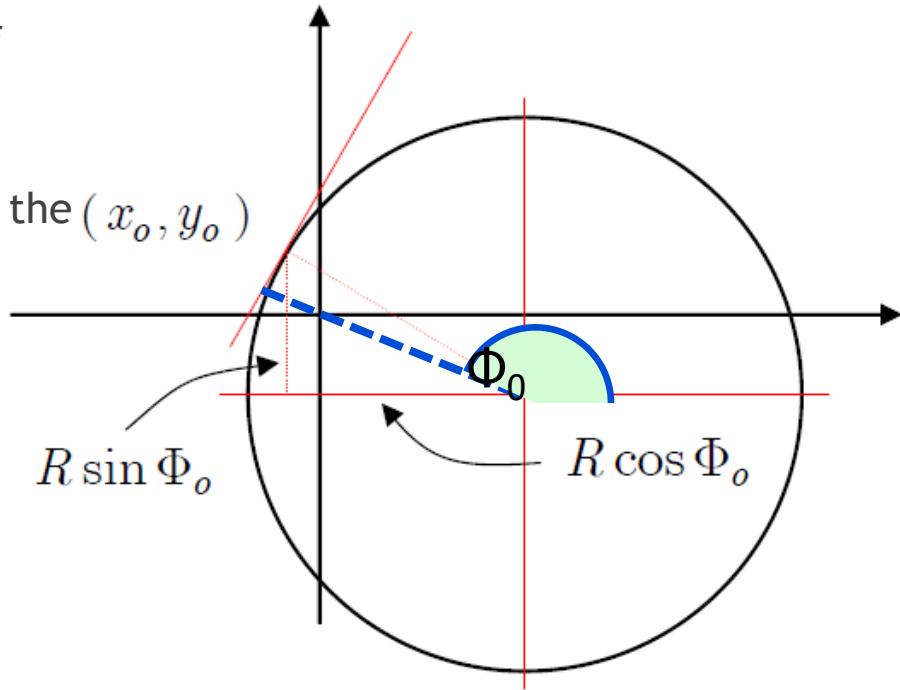
- $x_0$  and  $y_0$  are the coordinates at  $s=0$
- $\Phi_0$  is also related to the slope of the tangent to the circle at  $s=0$



# High- $p_T$ parabolic approximation

- In the helix equation:
  - The  $s=0$  point is an arbitrary choice
  - A common use case is when the track is reconstructed in a region of size  $\ll R$ 
    - $p_T=1 \text{ GeV}$ ,  $B=2 \text{ T}$ ,  $R=1.7 \text{ m}$
    - radius of ATLAS tracking system is  $1.05 \text{ m}$
    - ...or if interested in the proximity of the interaction region:  
 $b, c, \tau$  decay in few mm
- Choose as reference point the closest one to the origin of the reference frame (i.e. detector center)
  - “perigee”
- Write as a Taylor expansion in  $s/R$ 
  - this is an approximation!
    - error  $\sim s^3/R^2$
  - but it will be very useful for future examples

$$p_T [\text{GeV}] = 0.3 B [\text{T}] R [\text{m}]$$



# High- $p_T$ parabolic approximation

- Development in  $s/R$ :

$$x(s) = x_0 - hs \cos \lambda \sin \Phi_0 - \frac{1}{2} \frac{s^2 \cos^2 \lambda}{R} \cos \Phi_0$$

$$y(s) = y_0 + hs \cos \lambda \cos \Phi_0 - \frac{1}{2} \frac{s^2 \cos^2 \lambda}{R} \sin \Phi_0$$

$$z(s) = z_0 + s \sin \lambda$$

- we can now introduce the “perigee” parameters:

- impact parameter  $d_0$ :

$$x_0 = d_0 h \cos \Phi_0, \quad y_0 = d_0 h \sin \Phi_0$$

notice it has a sign!

- the direction of the track at the perigee  $\varphi_0$ :

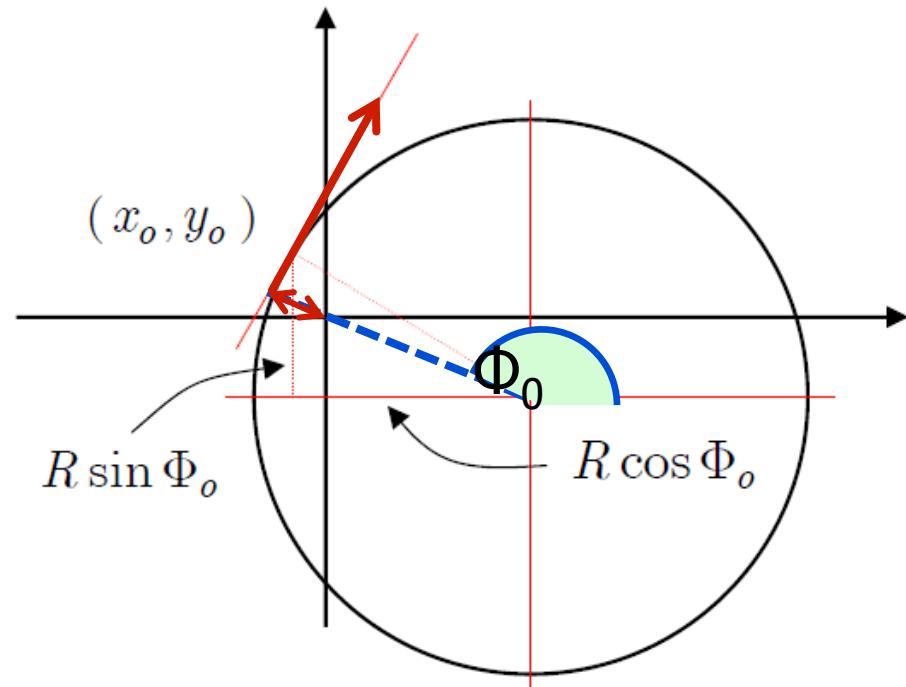
$$\cos \varphi_0 = h \sin \Phi_0, \quad \sin \varphi_0 = -h \cos \Phi_0$$

- the curvature  $\kappa = \frac{h}{R}$

which includes the sign of the charge

$$\vartheta = \frac{\pi}{2} - \lambda$$

- and the polar angle



$x(s)$	$= -d_0 \sin \varphi_0 + s \sin \vartheta \cos \varphi_0 + \frac{1}{2} \kappa s^2 \sin^2 \vartheta \sin \varphi_0$
$y(s)$	$= d_0 \cos \varphi_0 + s \sin \vartheta \sin \varphi_0 - \frac{1}{2} \kappa s^2 \sin^2 \vartheta \cos \varphi_0$
$z(s)$	$= z_0 + s \cos \vartheta$

# High-p<sub>T</sub> parabolic approximation

- Starting from the parametric trajectory
  - It is now interesting to define a change of coordinates with the x-axis directed along the track direction:
  - In these coordinates the trajectory has a simple expression in the “transverse” and “longitudinal” planes:
- $$x(s) = -d_0 \sin \phi_0 + s \sin \vartheta \cos \phi_0 + \frac{1}{2} \kappa s^2 \sin^2 \vartheta \sin \phi_0$$
- $$y(s) = d_0 \cos \phi_0 + s \sin \vartheta \sin \phi_0 - \frac{1}{2} \kappa s^2 \sin^2 \vartheta \cos \phi_0$$
- $$z(s) = z_0 + s \cos \vartheta$$
- $$\rho(s) = s \sin \vartheta$$
- $$y'(s) = d_0 - \frac{1}{2} \kappa s^2 \sin^2 \vartheta$$
- $$z(s) = z_0 + s \cos \vartheta$$
- Often  $r=\sqrt{x^2+y^2}$  is used instead of  $\rho$ :
    - this is a “double” approximation valid for  $rd_0$
    - If rotating to an axis “near” to the particle direction (the jet-axis for example)

$$z = z_0 + \rho \cot \vartheta$$
$$y' = d_0 - \frac{1}{2} \kappa \rho^2$$

$$y' = d_0 + \rho \tan(\varphi_0 - \varphi_{\text{jet}}) - \frac{1}{2} \kappa \rho^2$$

- This will be our “workhorse”



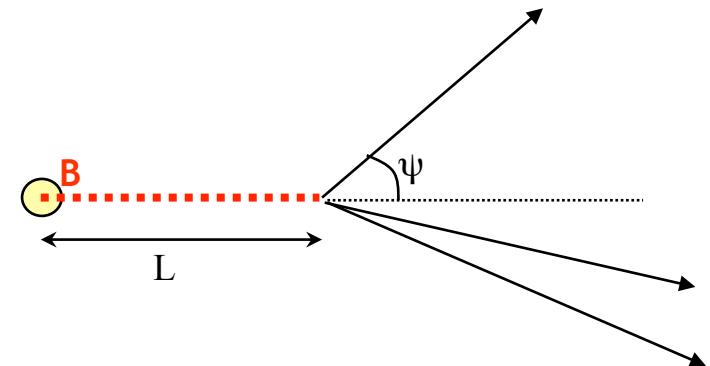
*The region near the interaction vertex*

# POSITION MEASUREMENTS



# Decay vertex reconstruction

- In proximity of the interaction region, at first order, it is possible to neglect the curvature:
  - focus on position and direction.
  - Example: detection of short-lived particles
- There is a group of particles with lifetimes of ~1 ps
- The flight length L can be measurable:  $L = \gamma\beta ct$
- To estimate the order of magnitude of the **decay angle**  $\psi$ , let's consider at which angle, with respect to the flight direction, a particle, emitted at an angle  $\theta^*$  in the rest frame of the mother particle, is observed in the laboratory frame:  
$$p^{\mu} = ( p^* \quad p^* \sin\theta^* \quad 0 \quad p^* \cos\theta^* )$$
- in the lab frame:  
$$p^{\mu} = [ \gamma p^*(1+\beta\cos\theta^*) \quad p^* \sin\theta^* \quad 0 \quad \gamma p^*(\cos\theta^* + \beta) ]$$
- therefore the decay angle is:  $\sin\psi = \frac{1}{\gamma} \frac{\sin\theta^*}{1+\beta\cos\theta^*} = O\left(\frac{1}{\gamma}\right)$



- Some typical examples:
  - Symmetric B-factory:  
 $\Upsilon(4S)$  at rest  
 $\gamma=1.002$ ,  $\beta=0.06$ ,  $L \sim 30 \text{ } \mu\text{m}$ ,  $\psi \sim 1^\circ$
  - Asymmetric B-factory:  
 $e^- 9 \text{ GeV}$ ,  $e^+ 3.1 \text{ GeV}$   
 $\gamma=1.15$ ,  $\beta=0.5$ ,  $L \sim 290 \text{ } \mu\text{m}$ ,  $\psi \sim 1^\circ$
  - High energy collisions (LEP, Tevatron, LHC)  
 $\gamma=5-10$ ,  $\beta=1$ ,  $L=2-3 \text{ mm}$ ,  $\psi \sim 0.1^\circ$

# Impact parameter

- It is useful to introduce the **impact parameter  $d$** , defined at the distance between the daughter particle trajectory and the mother particle production point:

$$d = L \sin \psi = O(\gamma \beta c \tau) \times O\left(\frac{1}{\gamma}\right) = O(c \tau)$$

- for relativistic particles is approximately independent of the boost.
- An experimental apparatus with decay vertex capabilities must be able to separate the production and decay vertices:

$$\sigma_L / L \ll 1$$

- As a practical example, let's consider a relativistic situation, where we can approximate:

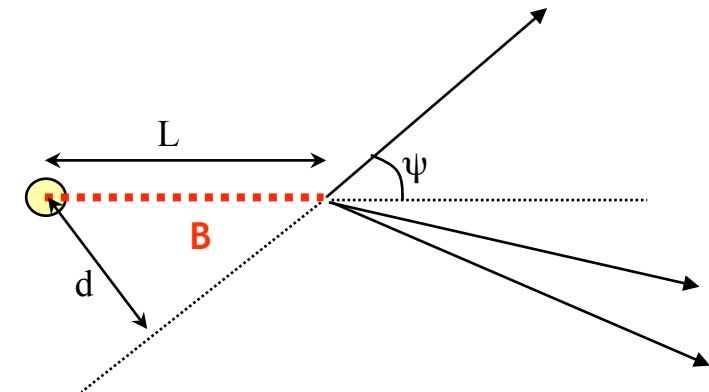
$$\tan \psi \approx \psi \approx \sin \psi$$

and set the x-axis direction along the mother particle flight direction.

- This apparatus reconstructs trajectories

$$y = \tan \psi_i x + d_i$$

with measurement uncertainty  $\sigma_d$   
( $\sigma_\psi$  is negligible in most practical cases)



- The decay vertex position is given by the intersection of two trajectories:

$$\begin{cases} y = \tan \psi_1 x + d_1 \\ y = \tan \psi_2 x + d_2 \end{cases}$$

$$L = \frac{d_2 - d_1}{\tan \psi_1 - \tan \psi_2} \approx \frac{d_2 - d_1}{\psi_1 - \psi_2}$$

$$\frac{\sigma_L}{L} = \frac{\sqrt{2} \sigma_d}{d_2 - d_1} = O\left(\frac{\sigma_d}{d}\right) = O\left(\frac{\sigma_d}{c \tau}\right)$$

# Impact parameter resolution

- Let's assume a pair of detector layers
  - at positions  $x_1$  and  $x_2$ ,
  - with a  $y$  coordinate measurement resolution  $\sigma_{y1}$  and  $\sigma_{y2}$ .
- The reconstructed trajectory is

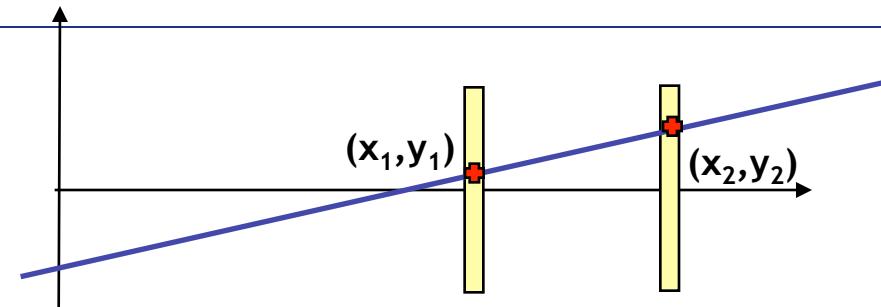
$$\frac{y - y_1}{y_2 - y_1} = \frac{x - x_1}{x_2 - x_1}$$

$$m = \frac{y_2 - y_1}{x_2 - x_1} \quad d_0 = \frac{x_2 y_1 - x_1 y_2}{x_2 - x_1}$$

- If  $\sigma_{y1} = \sigma_{y2} = \sigma_y$  the impact parameter uncertainty is given by

$$\sigma_d = \sqrt{\frac{n^2 + 1}{(n - 1)^2}} \sigma_y$$

where  $n = x_2 / x_1$  is referred to “lever arm”



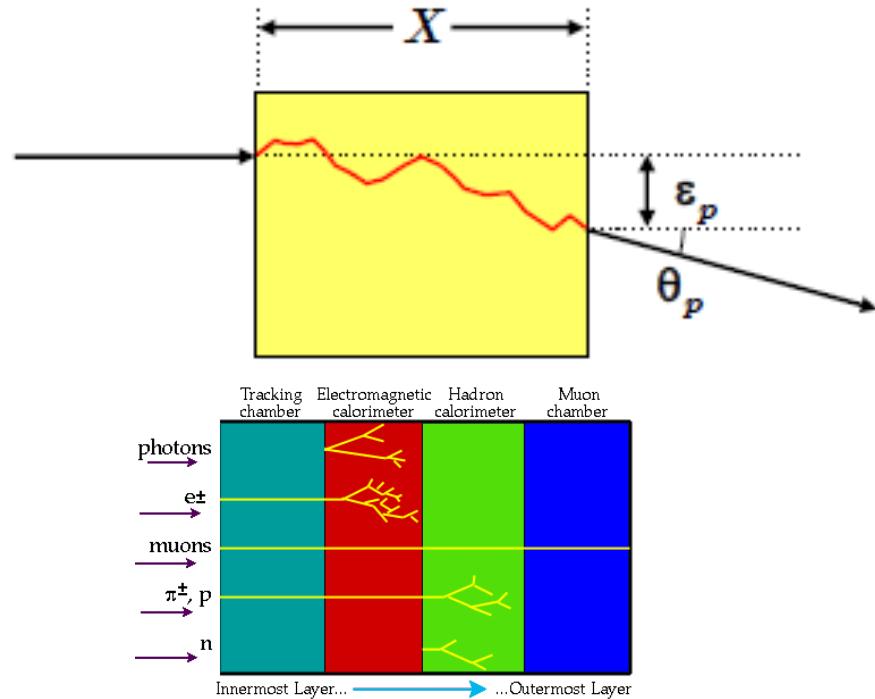
$$C_{d_0, m} = \begin{pmatrix} \frac{\partial d_0}{\partial y_1} & \frac{\partial d_0}{\partial y_2} \\ \frac{\partial m}{\partial y_1} & \frac{\partial m}{\partial y_2} \end{pmatrix} \begin{pmatrix} \sigma_{y1}^2 & 0 \\ 0 & \sigma_{y2}^2 \end{pmatrix} \begin{pmatrix} \frac{\partial d_0}{\partial y_1} & \frac{\partial m}{\partial y_1} \\ \frac{\partial d_0}{\partial y_2} & \frac{\partial m}{\partial y_2} \end{pmatrix}$$

$$\boxed{\frac{1}{(x_2 - x_1)^2} \begin{pmatrix} x_2^2 \sigma_{y1}^2 + x_1^2 \sigma_{y2}^2 & -(x_2 \sigma_{y1}^2 + x_1 \sigma_{y2}^2) \\ -(x_2 \sigma_{y1}^2 + x_1 \sigma_{y2}^2) & \sigma_{y1}^2 + \sigma_{y2}^2 \end{pmatrix}}$$

- The geometrical coefficient  $n$  in front of  $\sigma_y$  is always greater than 1.
- $x_1$  should be as small as possible. Usually limited by the accelerator beam pipe.
- $x_2$  is limited by cost

# Multiple scattering

- All'uscita in di un materiale una particella subisce:
  - una deviazione  $\theta_p$
  - uno spostamento  $\varepsilon_p$
- spesso  $\varepsilon_p$  è trascurabile.
- Non è sempre il caso per grandi spessori:
  - es.: nell'attraversamento dei calorimetri tra tracciatore interno e sistema a muoni



- Si può dimostrare che:

- dato:  $\langle \theta_p^2 \rangle = KX$ ,  $K = \left( \frac{13.6 \text{ MeV}}{\beta cp} z \right)^2 \frac{1}{X_0}$

- vale:

$$\langle \varepsilon_p^2 \rangle = \frac{1}{3} K X^3$$

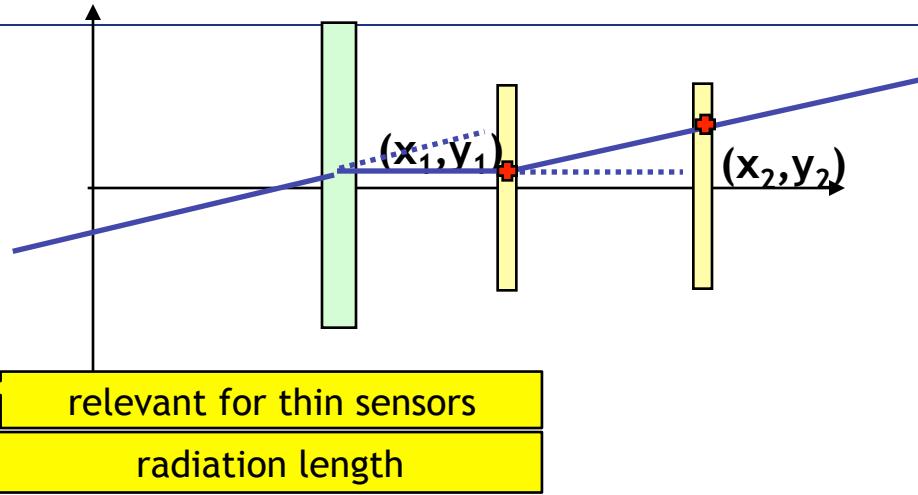
$$\langle \varepsilon_p \theta_p \rangle = \frac{1}{2} K X^2$$

- Il coefficiente di correlazione tra  $\theta_p$  e  $\varepsilon_p$  è  $\sqrt{3}/2=0.87$
- Hint: scrivere la formula per spessori discreti e passare al continuo.

# Impact parameter resolution: multiple scattering

- Multiple scattering has a critical role in determining the impact parameter resolution.
- Every material layer crossed by the particle before reaching the detector introduce a random deviations with r.m.s.

$$\theta_p = \frac{13.6 \text{ MeV}}{\beta cp} z \sqrt{\frac{X}{X_0}} \left( 1 + 0.038 \ln \frac{X}{X_0} \right)$$



- This deviation contributes to the track parameter uncertainties:

$$\delta d_0 = -R \cdot \theta_p \quad \delta m = \theta_p$$

where  $R$  is the distance between the interaction point and the material layer.

- Summing all contribution in quadrature:

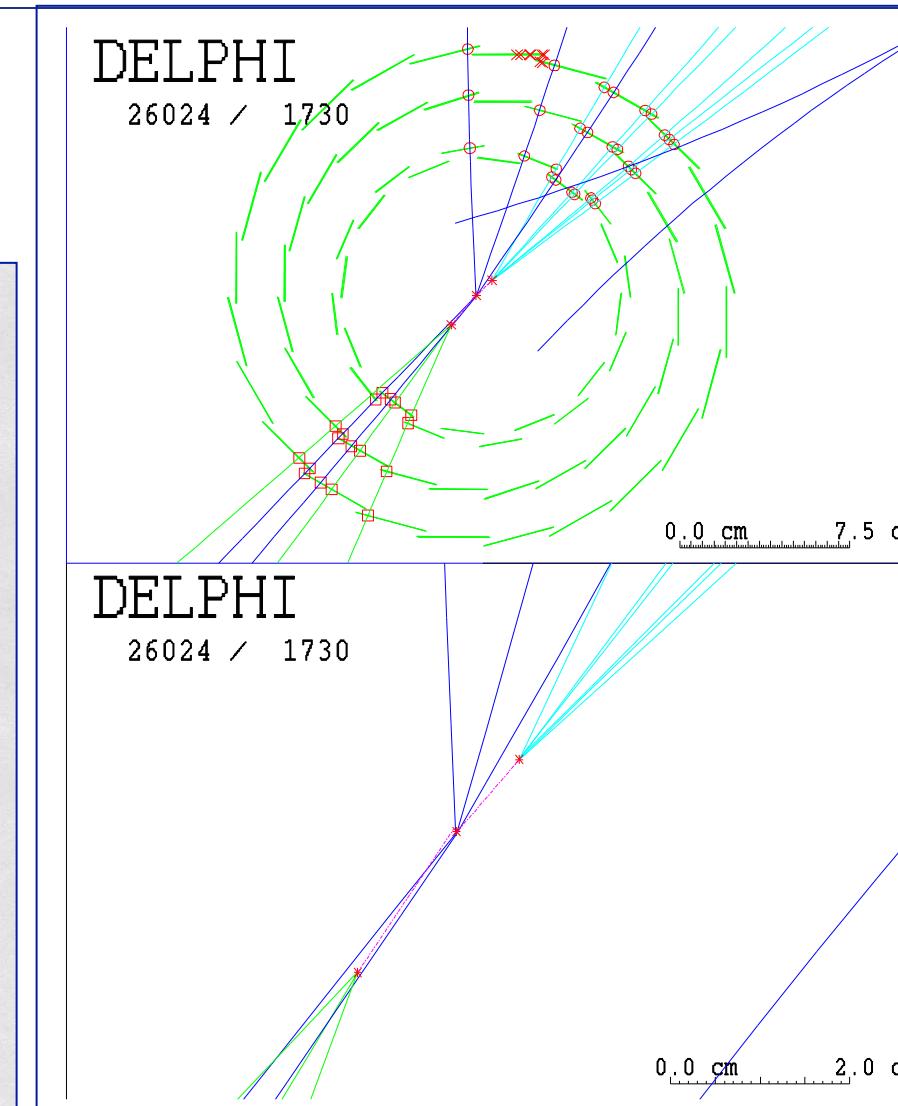
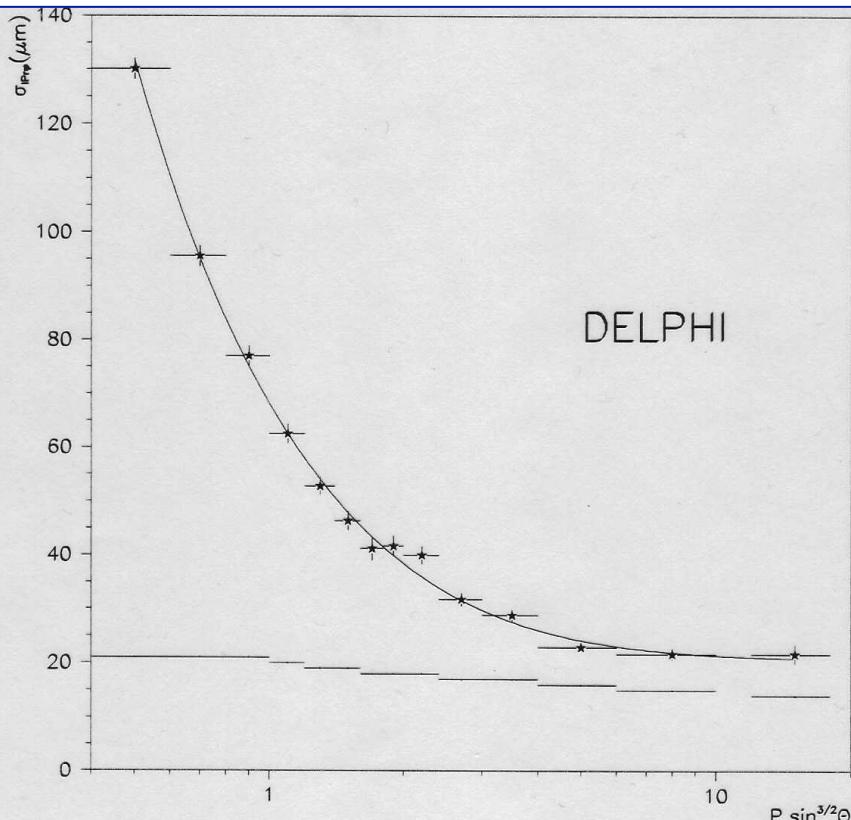
$$C_{d_0,m} = \begin{pmatrix} \sum_i R_i^2 \theta_{p,i}^2 & - \sum_i R_i \theta_{p,i}^2 \\ - \sum_i R_i \theta_{p,i}^2 & \sum_i \theta_{p,i}^2 \end{pmatrix} \approx \frac{1}{p \sin^{3/2} \theta}$$

- The sum runs on all material layers till the first measured point (included).
- The formula for  $\theta_p$  is valid only in a plane perpendicular to the track. If it is inclined by an angle  $\vartheta$  with respect to the  $xy$  plane, the scattering angle is amplified by a geometrical factor  $1/\sin\vartheta$ .
- Also the thickness  $X$  of the crossed material layer increases by an additional factor  $1/\sin^{1/2}\vartheta$ .

# Impact parameter and vertex reconstruction

- Often the impact parameter resolution is parameterized as

$$\sigma_d = \sigma_{\text{tracking}} \oplus \frac{\sigma_{\text{ms}} [\mu\text{m} \cdot \text{GeV}]}{p \sin^{3/2} \vartheta}$$



# Some practical examples

	DELPHI	SLD
detector type	microstrips	CCD
pitch	25 $\mu\text{m}$ (lettura 50 $\mu\text{m}$ )	20 $\mu\text{m} \times 20 \mu\text{m}$
beam pipe	$R=5.25 \text{ cm}, l=0.4\% X_0$	$R=2.35 \text{ cm}, l=0.5\% X_0$
first detector layer	$R=6.3 \text{ cm}, l=0.5\% X_0$	$R=2.80 \text{ cm}, l=0.4\% X_0$
last detector layer	$R=10.7 \text{ cm}, l=0.5\% X_0$	$R=4.83 \text{ cm}, l=0.4\% X_0$
point resolution	8 $\mu\text{m}$	4.4 $\mu\text{m}$
$\sigma_{\text{tracking}}$	20 $\mu\text{m}$	11 $\mu\text{m}$
$\sigma_{\text{ms}}$	measured values	33 $\mu\text{m} \times \text{GeV}$
	65 $\mu\text{m} \times \text{GeV}$	

$$\sigma_d = \frac{\sqrt{x_2^2 + x_1^2}}{x_2 - x_1} \sigma_y \quad \rightarrow \quad \sigma_d = \sigma_{\text{tracking}} \oplus \frac{\sigma_{\text{ms}}}{p \sin^{3/2} \vartheta} \quad \leftarrow \quad \sigma_d = \sqrt{\sum_i R_i^2 \theta_{0,i}^2}$$

*Determining curvature*

# MOMENTUM MEASUREMENT



# Momentum measurement (sagitta)

- A widespread method, if it is possible to insert detectors inside the magnetic field, consists of measuring the sagitta of the particle trajectory:

$$s = R \left( 1 - \cos \frac{\theta}{2} \right) \approx R \frac{\theta^2}{8}$$
$$= \frac{qBL^2}{8p}$$

- Numerically:

$$s[\text{m}] = \frac{0.3B[\text{T}]L^2[\text{m}]}{p[\text{GeV}/c]}$$

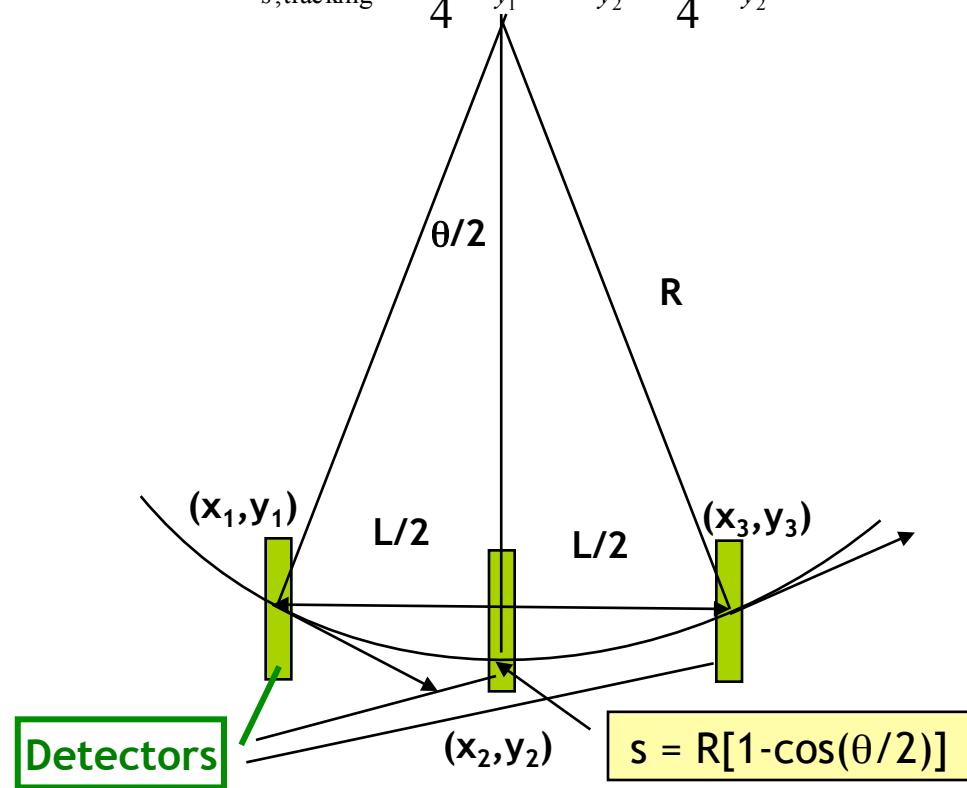
- And the relative momentum resolution is:

$$\frac{\sigma_p}{p} = \frac{\sigma_s}{s} = \frac{8p}{0.3BL^2} \sigma_s$$

- In the case the sagitta is measured by only three detectors:

$$s = y_2 - \frac{1}{2}(y_1 + y_3)$$

$$\sigma_{s,\text{tracking}}^2 = \frac{1}{4}\sigma_{y_1}^2 + \sigma_{y_2}^2 + \frac{1}{4}\sigma_{y_3}^2$$



# Momentum measurement: multiple scattering

- In case of deflection in the detector material:

$$\delta y_2 = \frac{L}{2} \delta\theta_1 \quad \delta y_3 = L \delta\theta_1 + \frac{L}{2} \delta\theta_2 \quad \Rightarrow \quad \delta s = \delta y_2 - \frac{1}{2} \delta y_3 = -\frac{L}{2} \delta\theta_2$$

and therefore a multiple scattering contribution of  $\sigma_s = \frac{L}{2} \theta_{p,2}$

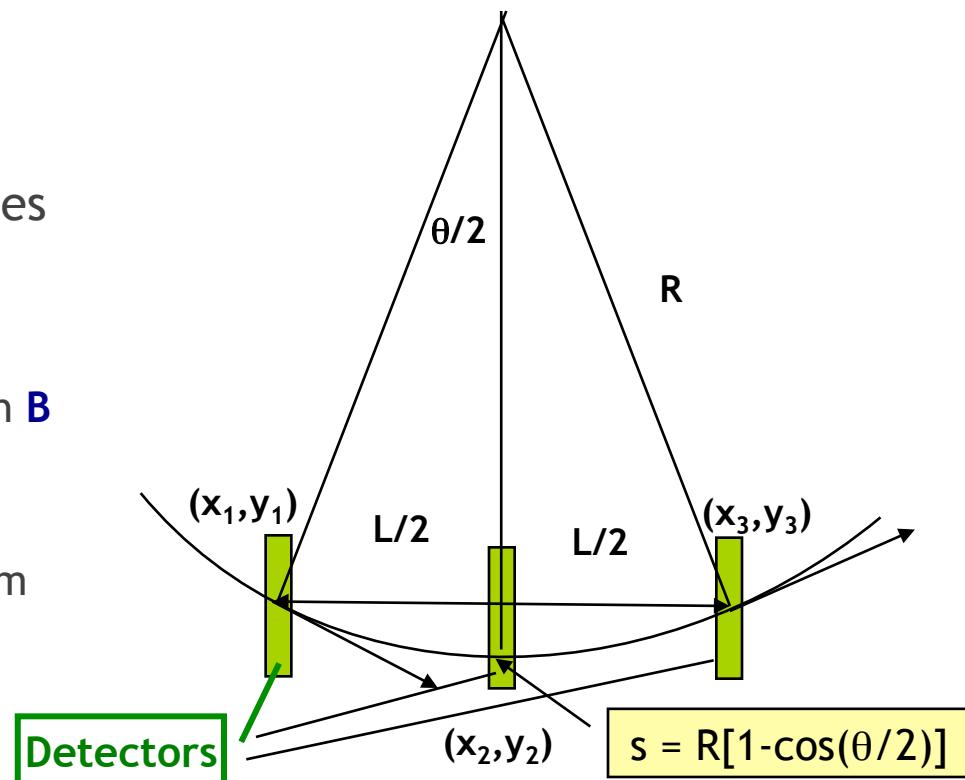
- Adding the two contributions:

$$\sigma_s = \sigma_{\text{tracking}} \oplus \frac{\sigma_{\text{MS}}}{p}$$

- And the momentum resolution becomes

$$\frac{\sigma_p}{p} = \frac{\sigma_s}{s} = \frac{8}{0.3BL^2} \left( p \sigma_{\text{tracking}} \oplus \sigma_{\text{MS}} \right)$$

- The resolutions improves **linearly** with **B** and with the **detector resolution**.
- It improves quadratically with L**
- The relative uncertainty on momentum is constant at low momentum (MS), but **increases linearly with increasing momentum**.



# Momentum measurement (bending)

- A widely used method consists of the measurements of the bending of the track direction after crossing a magnetic field.
- A particle moving across a region with a constant magnetic field will get a pulse of

$$\Delta p_T \approx pL/R = qBL$$

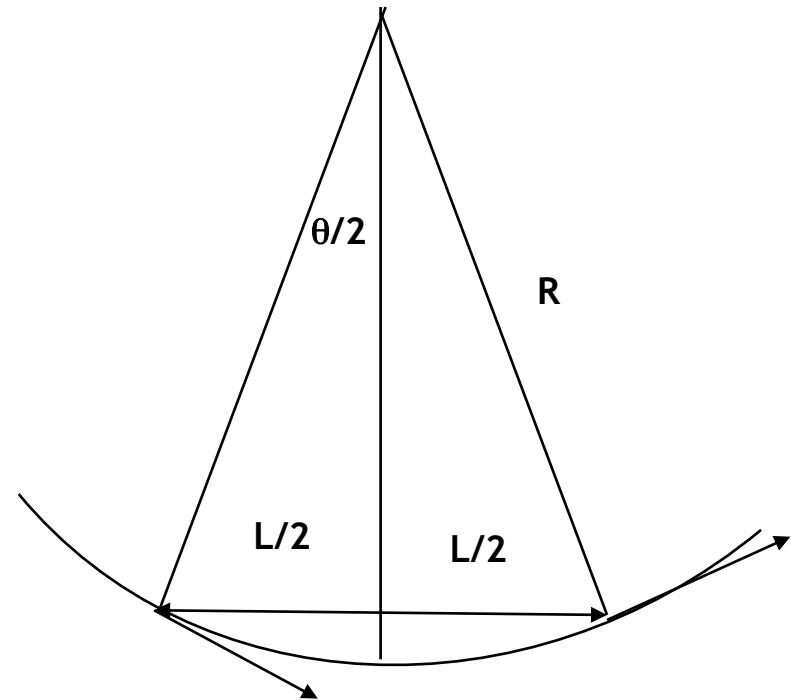
- The more general formula for non-constant magnetic field is:

$$\Delta p_T \approx q \int B dl$$

bending power

- It is therefore possible to determine the momentum of a particle by the angular deviation after crossing a magnetic field:

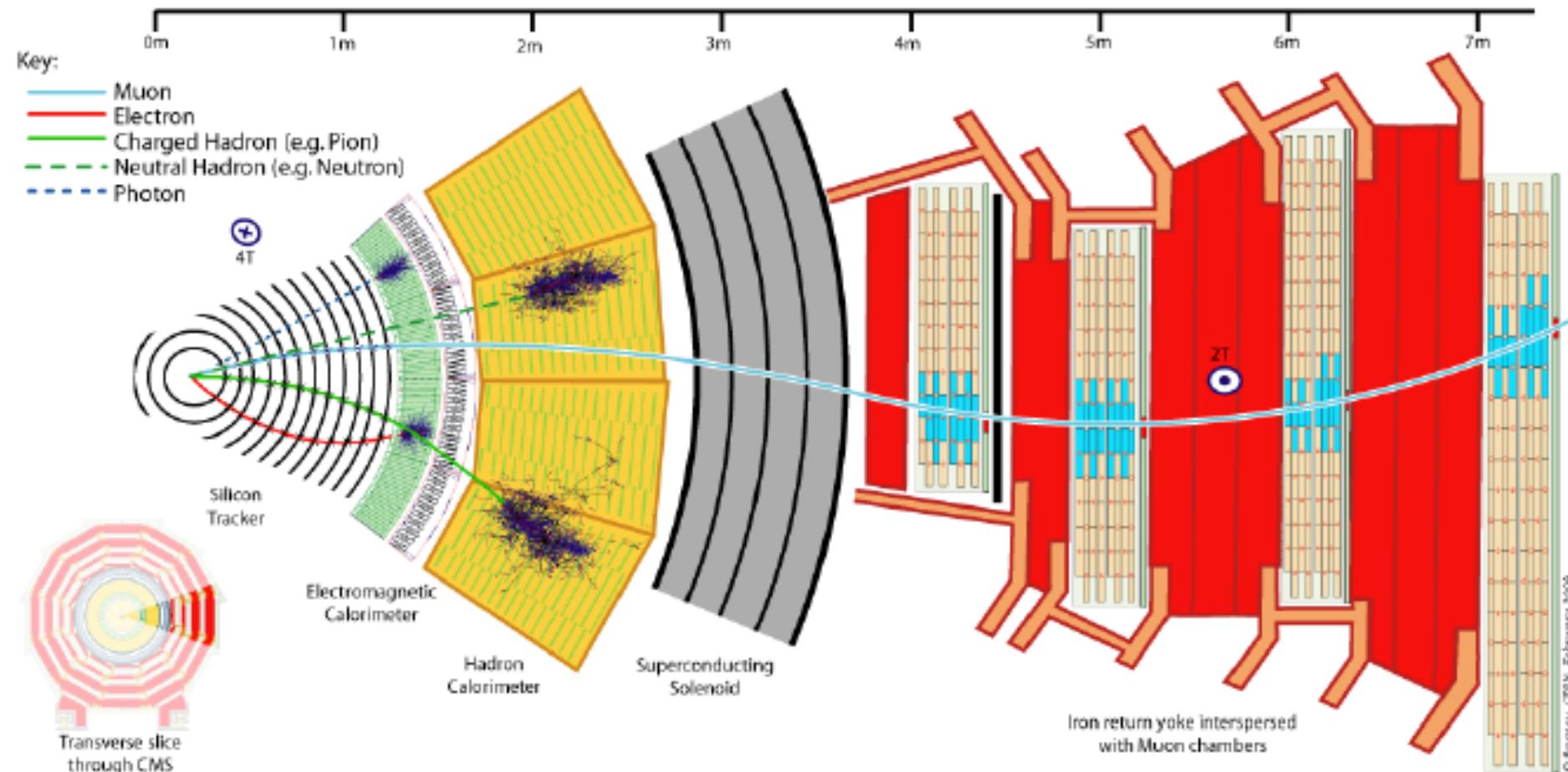
$$\theta \approx \frac{\Delta p_T}{p_T} = \frac{q \int B dl}{p_T}$$



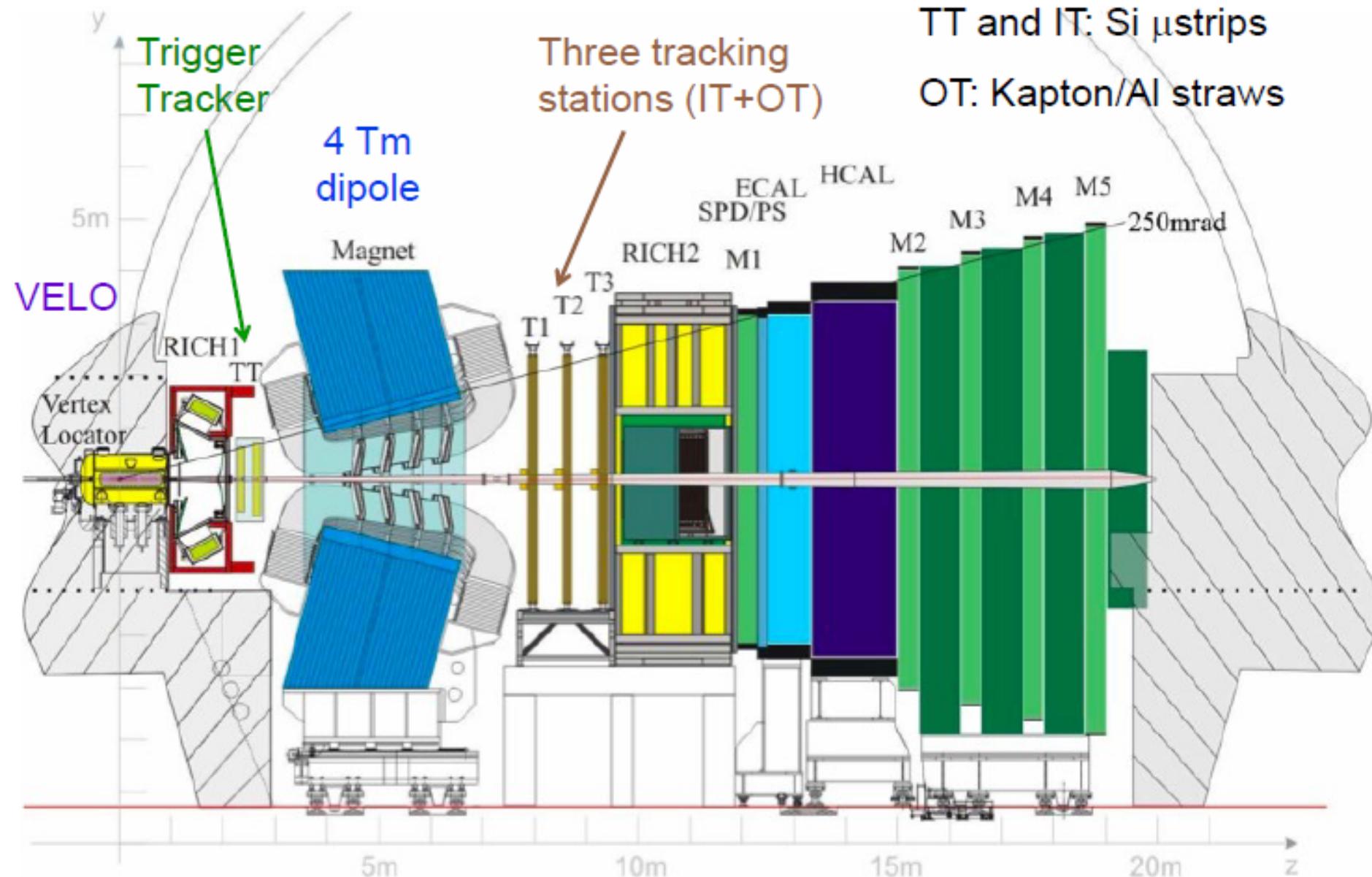
- Also in this case, the relative uncertainty worsens with increasing momentum:

$$\frac{\sigma_{p_T}}{p_T} = \frac{\sigma_\theta}{\theta} = \frac{p_T \sigma_\theta}{q \int B dl}$$

# CMS: Compact Muon Solenoid



# LHCb tracking

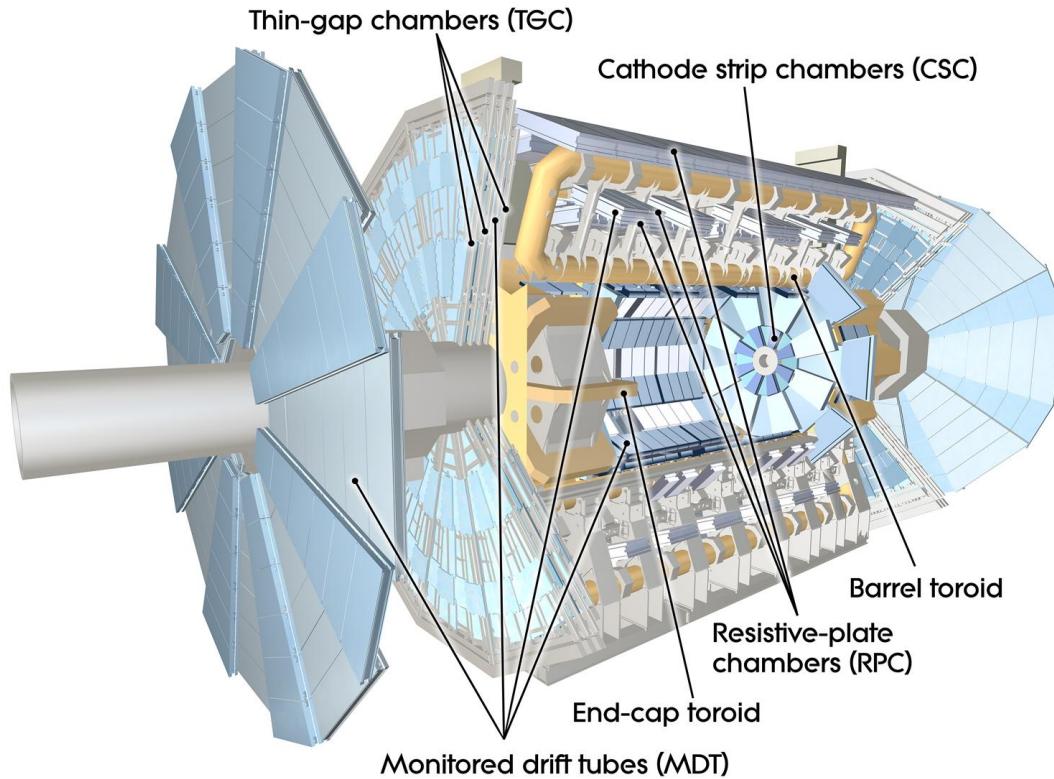


VELO:  $r\phi$  Si strips

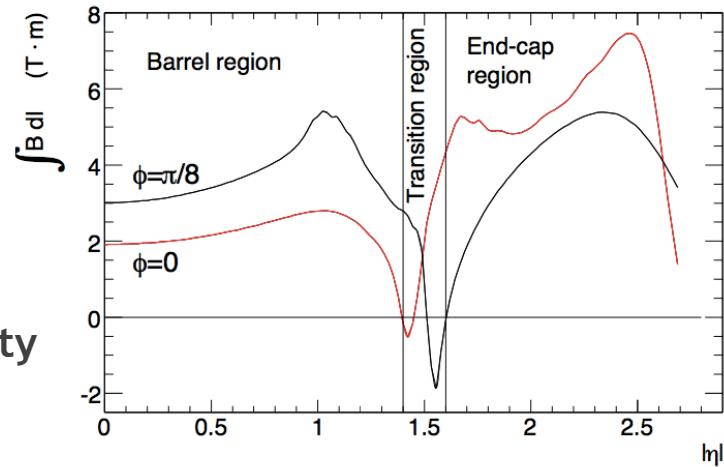
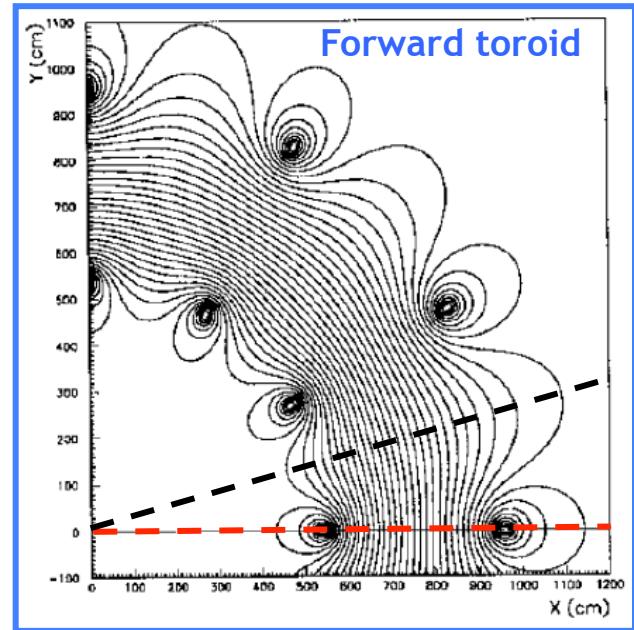
TT and IT: Si  $\mu$ strips

OT: Kapton/Al straws

# ATLAS Muon Spectrometer



- **Instrumented air-core toroid system:**
  - bending power 1-7.5 Tm
  - standalone momentum reconstruction capability  $\sigma_{pT}/p_T = 10\%$  at  $p_T=1$  TeV

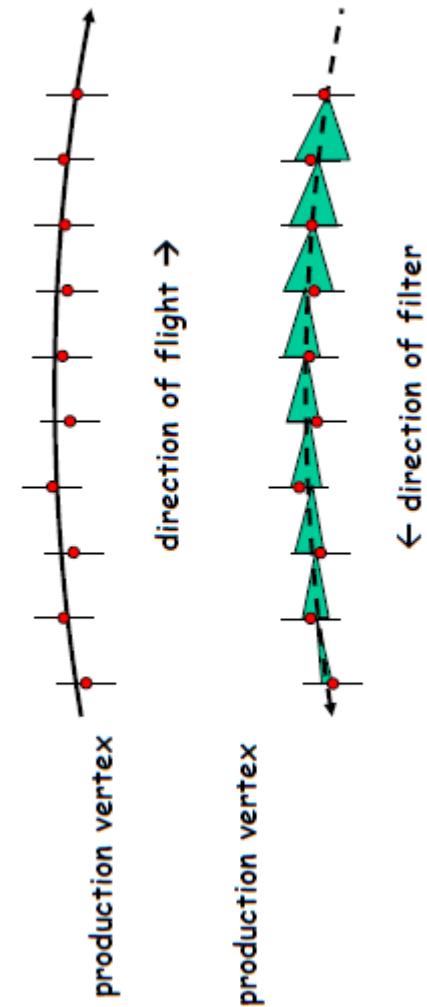


1. *Kalman filter*
2. *Other approaches to fitting*
3. *Elements of track finding*
4. *Examples of tracking systems*

# TRACK FITTING AND FINDING

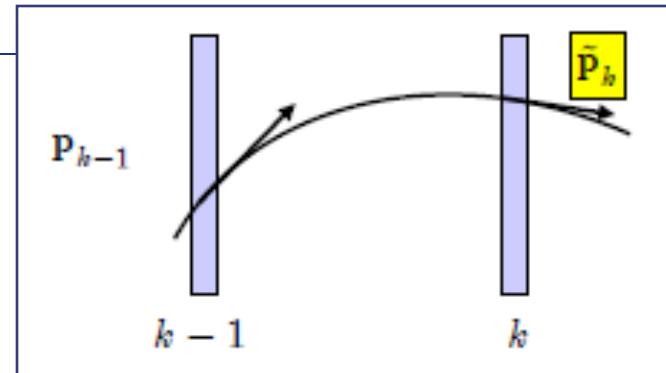
# Kalman filter

- Step-by-step updating procedure:
  - use initial estimation of track parameters
  - extrapolate to next measured point
  - compare extrapolation with measurement
  - derive updated track parameters
- Continue adding all points one at the time.
- For each point invert a matrix of size equal to the track parameters
  - computation time is  $Nd^3$  instead of  $N^3$
  - $N$ =number of measurements
  - $d$ =number of track parameters
- Comparison allows for rejection of outliers
  - can also be used during pattern recognition



# Kalman filter

- Only providing basic idea of Kalman filtering
  - one iteration of the fit, from detector plane  $k-1$  to  $k$
  - see bibliography<sup>(\*)</sup> for more details
- At plane  $k-1$  we have:
  - $\mathbf{p}_{k-1}$ : estimation of the track parameters
  - $\mathbf{C}_{k-1}$ : covariance matrix
- Extrapolation to plane  $k$ :
  - new parameters:  $\tilde{\mathbf{p}}_k = \mathbf{f}(\mathbf{p}_{k-1})$
  - Jakobian matrix:  $\mathbf{F} = \frac{\partial \mathbf{f}}{\partial \mathbf{p}}(\mathbf{p}_{k-1})$
  - covariance matrix of the extrapolated parameters:  
$$\tilde{\mathbf{C}}_k = \mathbf{F} \mathbf{C}_{k-1} \mathbf{F}^T + \mathbf{M}_{ms}$$
- $\mathbf{M}_{ms}$ : includes the multiple scattering uncertainty in the extrapolation.



- On surface  $k$  we have some measurements  $\mathbf{m}_k$  with covariance  $\mathbf{V}_k$ .
- The updated parameters  $\mathbf{p}_k$  are obtained by minimizing a  $\chi^2$  including:
  - comparison of  $\mathbf{m}_k$  with expectations  $\mathbf{y}_k(\mathbf{p}_k)$  from the track model
  - the extrapolated parameters
$$\begin{aligned}\chi^2 = & (\mathbf{m}_k - \mathbf{y}_k(\mathbf{p}_k))^T \mathbf{V}_k^{-1} (\mathbf{m}_k - \mathbf{y}_k(\mathbf{p}_k)) \\ & + (\tilde{\mathbf{p}}_k - \mathbf{p}_k)^T \tilde{\mathbf{C}}_k^{-1} (\tilde{\mathbf{p}}_k - \mathbf{p}_k)\end{aligned}$$

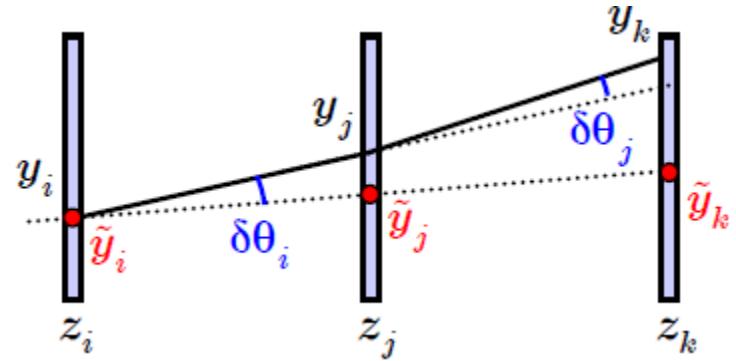
(\*) Boch, Grote, Notz, Regler, *Data analysis techniques in high energy physics experiments*, Cambridge University Press 1990

# Kalman filter: straight line example

- Initial estimate of track parameters using  $j, k$

$$y = a_j + b_j(z - z_j)$$

$$\mathbf{p}_j = \begin{pmatrix} a_j \\ b_j \end{pmatrix} = \begin{pmatrix} y_j \\ \frac{y_k - y_j}{z_k - z_j} \end{pmatrix} \quad \mathbf{C}_j = \begin{pmatrix} \sigma_{y_j}^2 & -\frac{\sigma_{y_j}^2}{z_k - z_j} \\ -\frac{\sigma_{y_j}^2}{z_k - z_j} & \frac{\sigma_{y_j}^2 + \sigma_{y_k}^2}{(z_k - z_j)^2} \end{pmatrix}$$



- Extrapolate to point  $i$ :  $y = a_j + b_j(z - z_j) \Rightarrow y = a_i + b_i(z - z_i)$

$$\tilde{\mathbf{p}}_i = \begin{pmatrix} \tilde{a}_i \\ \tilde{b}_i \end{pmatrix} = \begin{pmatrix} a_j - b_j(z_j - z_i) \\ b_j \end{pmatrix}$$

$$\tilde{\mathbf{C}}_j = \frac{1}{(z_k - z_j)^2} \begin{pmatrix} (z_k - z_i)^2 \sigma_{y_j}^2 + (z_j - z_i)^2 \sigma_{y_k}^2 & -(z_k - z_i) \sigma_{y_j}^2 - (z_j - z_i) \sigma_{y_k}^2 \\ -(z_k - z_i) \sigma_{y_j}^2 - (z_j - z_i) \sigma_{y_k}^2 & \sigma_{y_j}^2 + \sigma_{y_k}^2 \end{pmatrix} + \theta_{p,j}^2 \begin{pmatrix} (z_j - z_i)^2 & z_j - z_i \\ z_j - z_i & 1 \end{pmatrix}$$

which gives contribution to the  $\chi^2$  for the parameters at  $i$ :

$$\chi^2 = (\tilde{\mathbf{p}}_i - \mathbf{p}_i)^T \tilde{\mathbf{C}}_j^{-1} (\tilde{\mathbf{p}}_i - \mathbf{p}_i) \quad \mathbf{p}_i = \begin{pmatrix} a_i \\ b_i \end{pmatrix}$$

# Kalman filter: straight line example

- The measurement at  $i$  is the  $y$  position at  $z_i$ :

$$y = a_i + b_i(z - z_i)$$

- in this case the term  $\mathbf{m}_i - \mathbf{y}_i(\mathbf{p}_i)$  has the form:

$$\mathbf{m}_i = (y_i) \quad \mathbf{y}_i(\mathbf{p}_i) = \mathbf{H}_i \mathbf{p}_i \quad \mathbf{H}_i = \begin{pmatrix} 1 & 0 \end{pmatrix}$$

$$\mathbf{m}_i - \mathbf{y}_i(\mathbf{p}_i) = y_i - \mathbf{H}_i \mathbf{p}_i = y_i - a_i \quad \Rightarrow \chi^2 = \frac{(y_i - a_i)^2}{\sigma_{y_i}^2}$$

- The new parameters are obtained by the minimization of:

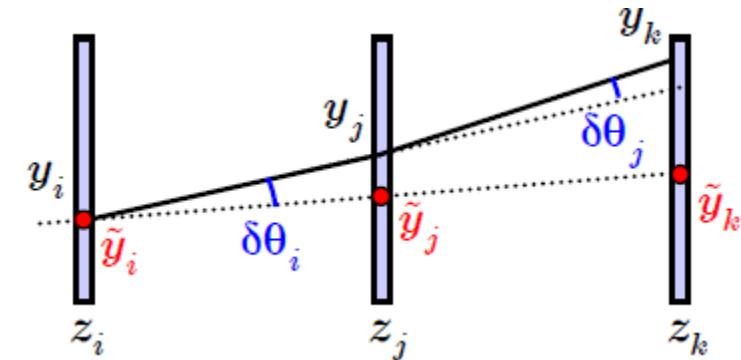
$$\chi^2 = (\tilde{\mathbf{p}}_i - \mathbf{p}_i)^T \tilde{\mathbf{C}}^{-1} (\tilde{\mathbf{p}}_i - \mathbf{p}_i) + \frac{(y_i - a_i)^2}{\sigma_{y_i}^2}$$

- Which can be put in the general  $x^2$  form:  $\chi^2 = (\mathbf{Y} - \mathbf{Ap})^T \mathbf{V}^{-1} (\mathbf{Y} - \mathbf{Ap})$

$$\mathbf{p} = \begin{pmatrix} a_i \\ b_i \end{pmatrix} \quad \mathbf{Y} = \begin{pmatrix} \tilde{a}_i \\ \tilde{b}_i \\ y_i \end{pmatrix} \quad \mathbf{A} = \begin{bmatrix} 1 & 0 \\ 0 & 1 \\ 1 & 0 \end{bmatrix} \quad \mathbf{V} = \begin{bmatrix} \tilde{\mathbf{C}}_i & \mathbf{0} \\ \mathbf{0} & \sigma_{y_i}^2 \end{bmatrix}$$

- whose solution is:

$$\mathbf{p} = (\mathbf{A}^T \mathbf{W} \mathbf{A})^{-1} \mathbf{A}^T \mathbf{W} \mathbf{Y} \quad \mathbf{C}_i = (\mathbf{A}^T \mathbf{W} \mathbf{A})^{-1} \quad \mathbf{W} = \mathbf{V}^{-1} = \begin{bmatrix} \tilde{\mathbf{C}}_i^{-1} & \mathbf{0} \\ \mathbf{0} & 1/\sigma_{y_i}^2 \end{bmatrix}$$



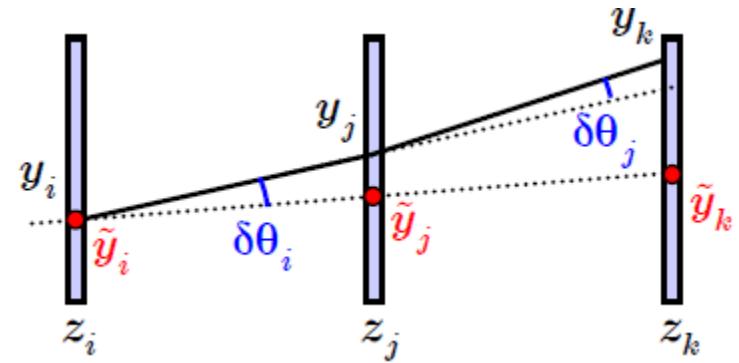
# Kalman filter: straight line example

- Finally, going to the interaction point:

$$y = a_0 + b_0 z$$

$$\mathbf{p}_0 = \begin{pmatrix} a_0 \\ b_0 \end{pmatrix} = \begin{pmatrix} a_i - b_i z_i \\ b_i \end{pmatrix}$$

$$\mathbf{C}_0 = \begin{pmatrix} 1 & -z_i \\ 0 & 1 \end{pmatrix} \mathbf{C}_i \begin{pmatrix} 1 & 0 \\ -z_i & 1 \end{pmatrix} + \theta_{p,i}^2 \begin{pmatrix} z_i^2 & -z_i \\ -z_i & 1 \end{pmatrix}$$



The first and second features are general characteristics of all track fitter

## Some important concepts:

- Track parameters depend on the point at which we are looking at the track:  
 $\mathbf{p}_0 \neq \mathbf{p}_i \neq \mathbf{p}_j$
- Even if at each point we are measuring  $y_i \approx a_i$ , the  $\chi^2$  minimization also changes the other track parameter  $b_i$  due to the correlations in  $\mathbf{C}_i$
- This predictor-corrector method can be used to reject measurements which are not consistent with the extrapolation, for example defining requirements on the  $\chi^2$ :

$$\chi^2 = (\mathbf{m}_i - \mathbf{y}_i(\tilde{\mathbf{p}}_i))^T \tilde{\mathbf{V}}_i^{-1} (\mathbf{m}_i - \mathbf{y}_i(\tilde{\mathbf{p}}_i)) \Rightarrow \chi^2 = \frac{(y_i - \tilde{a}_i)^2}{\sigma_{y_i}^2 + \sigma_{a_i}^2}$$

# Kalman filter: exercises

- Exercise 1 (needed for Geant4 practical exercises)
  - repeat the same computation for a parabolic trajectory
  - In case multiple scattering can be neglected, compute the initial parameters and their covariance matrix, using 3 measurement planes, spaced by a length  $l$  and with a measurement uncertainty  $\sigma$
- Exercise 2
  - apply the Kalman filter method to a sequence of measurements  $y_i$ ,  $i=0\dots N$  of a physics quantity  $a$ , each with its own uncertainty  $\sigma_i$
  - show this method is equivalent to the weighted mean
- Exercise 3
  - the best estimation of the parameters at a point  $i$ ,  $p_i$ , can be obtained performing a forward Kalman filter (points from 1 to  $i$ ) and a backward one (points from  $i$  to  $N$ ). Indicating with  $p_f$ ,  $C_f$ ,  $p_b$ ,  $C_b$ , respectively, the parameters and their covariance matrices of these two fits, try to give an expression for  $p_i$  and  $C_i$ .



# Global $\chi^2$ fit

- If Kalman filter is the common choice if many measurements
- In modern experiments often few,  $N=O(10)$ , measurements with high resolution:
  - inverting the correlation matrix is computationally feasible
  - minimization of a global  $\chi^2$  including all measurements at once
- It is interesting to see how multiple scattering is taken into account.
  - No multiple scattering:
    - $N$  measurements
    - 2 parameters
    - $N-2$  degrees of freedom
  - With multiple scattering
    - $N$  additional parameters: scattering angles
    - $N$  constraints:  $\langle \varphi_{ms,k} \rangle = 0$   $\langle \varphi_{ms,k}^2 \rangle = \theta_{ms,k}^2$
    - $2N-(N+2)$  degrees of freedom

## No Multiple scattering

$$y(z) = a + bz$$

$$\chi^2 = \sum_{k=1,N} \frac{(y_k - a - bz_k)^2}{\sigma_k^2}$$

## With Multiple scattering

$$y(z) = \begin{cases} a + bz & z \leq z_1 \\ a + bz + b_{ms,1}(z - z_1) & z_1 < z \leq z_2 \\ a + bz + b_{ms,1}(z - z_1) \\ + b_{ms,2}(z - z_2) & z_2 < z \leq z_3 \\ \vdots \\ a + bz + \sum_{k=1,N} b_{ms,k}(z - z_k) & z > z_N \end{cases}$$

$$b_{ms,k} = \tan \varphi_{ms,k}$$

$$\chi^2 = \sum_{k=1,N} \frac{(y_k - y(z_k))^2}{\sigma_k^2} + \frac{\varphi_{ms,k}^2}{\theta_{ms,k}^2}$$



# Vertex fit (trivial)

- Take a set of tracks fitted as straight lines:

$$\begin{cases} x = d_{0,i} \sin \varphi_i + s \cos \varphi_i \\ y = -d_{0,i} \cos \varphi_i + s \sin \varphi_i \end{cases}$$

$$d_{0,i} - x \sin \varphi_i + y \cos \varphi_i = 0$$

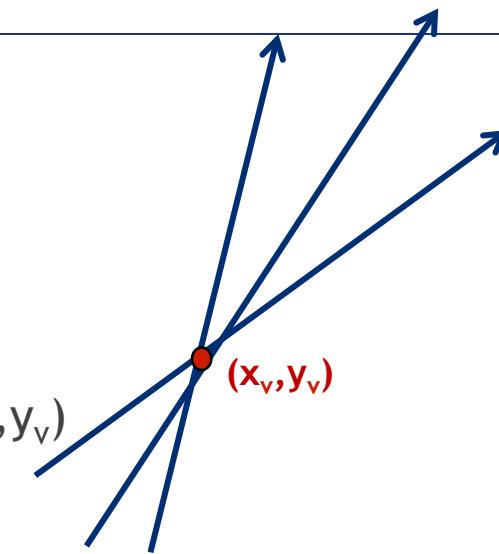
- Assume they have been produced at a single point  $(x_v, y_v)$
- Determine the point that minimizes:

$$\chi^2 = \sum_{\text{tracks}} \frac{(d_{0,i} - x_v \sin \varphi_i + y_v \cos \varphi_i)^2}{\sigma_{d,i}^2}$$

- The problem is only apparently linear:  
the uncertainty on the distance depends from vertex position:

$$\sigma_{d,i}^2 = \left( \begin{array}{cc} 1 & -x_v \cos \phi_i - y_v \sin \phi_i \end{array} \right) \left[ \begin{array}{cc} \sigma_{d_{0,i}}^2 & \sigma_{d_{0,i}, \phi_i} \\ \sigma_{d_{0,i}, \phi_i} & \sigma_{\phi_i}^2 \end{array} \right] \left( \begin{array}{c} 1 \\ -x_v \cos \phi_i - y_v \sin \phi_i \end{array} \right)$$

- it is linear only when the uncertainty on direction can be neglected.



# Vertex fit

- The real model consists of  $N_{\text{tracks}} + 2$  parameters
  - the 2 vertex coordinates:  $x_v, y_v$
  - the  $N_{\text{tracks}}$  directions at the vertex:  $\phi_{v,i}$

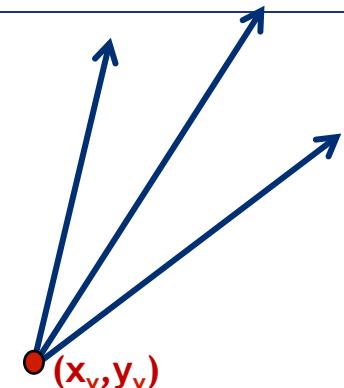
- And there are  $2N_{\text{tracks}}$  observables

- the trajectory parameters:  $d_{0,i}, \phi_i$

- resulting in the more complex

$$\chi^2 = \sum_{\text{tracks}} \begin{pmatrix} d_{0,i} - x_v \sin \phi_{v,i} + y_v \cos \phi_{v,i} & \phi_j - \phi_{v,i} \end{pmatrix} \begin{bmatrix} \sigma_{d_{0,i}}^2 & \sigma_{d_{0,i}, \phi_j} \\ \sigma_{d_{0,i}, \phi_j} & \sigma_{\phi_j}^2 \end{bmatrix}^{-1} \begin{pmatrix} d_{0,i} - x_v \sin \phi_{v,i} + y_v \cos \phi_{v,i} \\ \phi_j - \phi_{v,i} \end{pmatrix}$$

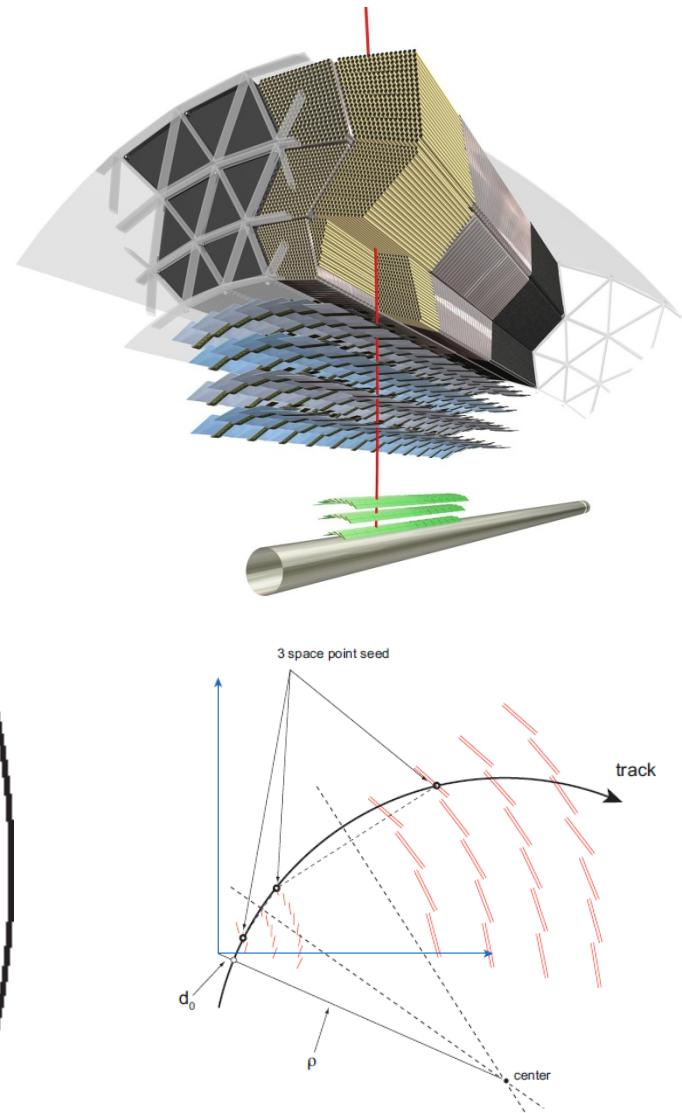
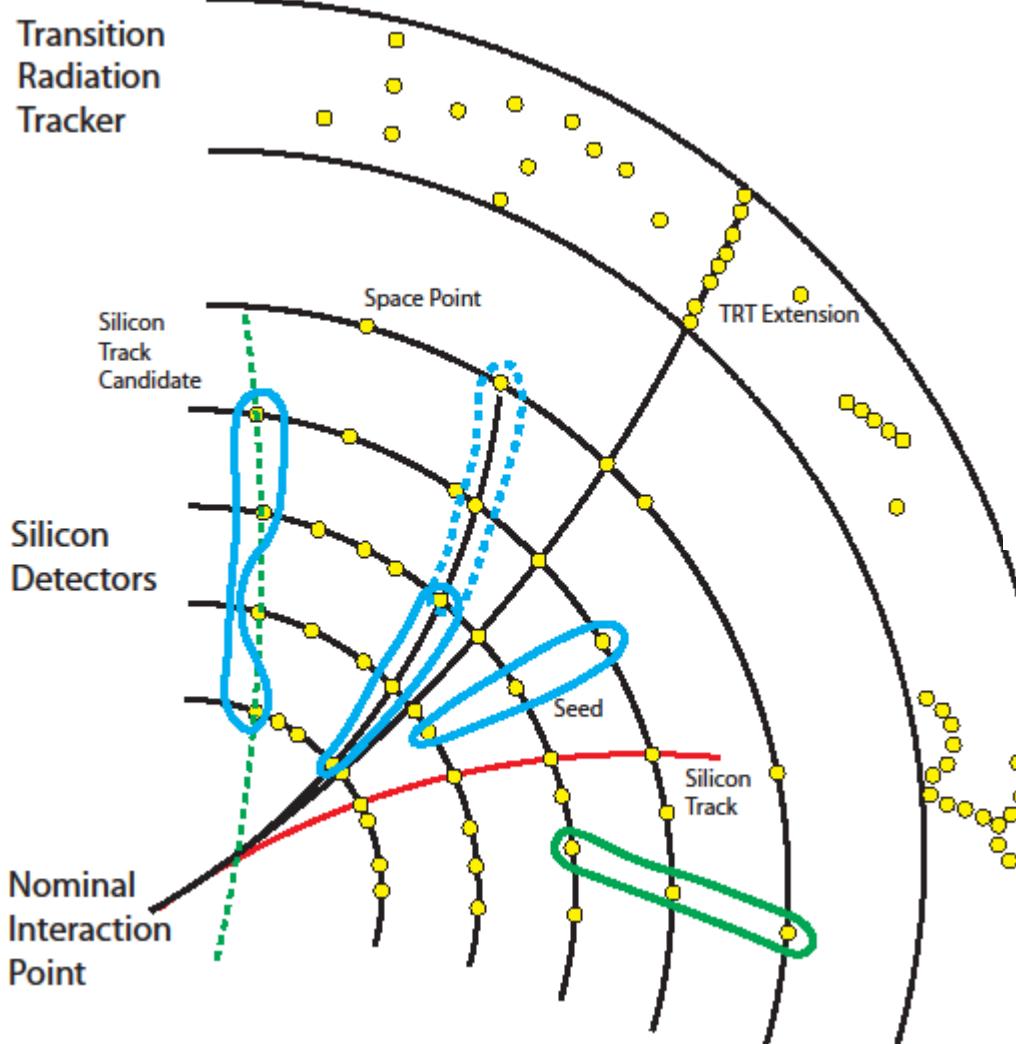
- Fitting a vertex is not simply “adding” something to a set of tracks
  - also track properties are modified:
    - the fact that all tracks come from a vertex actually constrains track parameters
    - basically the vertex is an additional measured point in the track fit
  - it is important to be sure tracks originate from the same vertex
    - iterative procedures removing tracks giving too high contributions to the  $\chi^2$
    - sometimes further constraints can be added (for example invariant mass of tracks associated to the vertex)



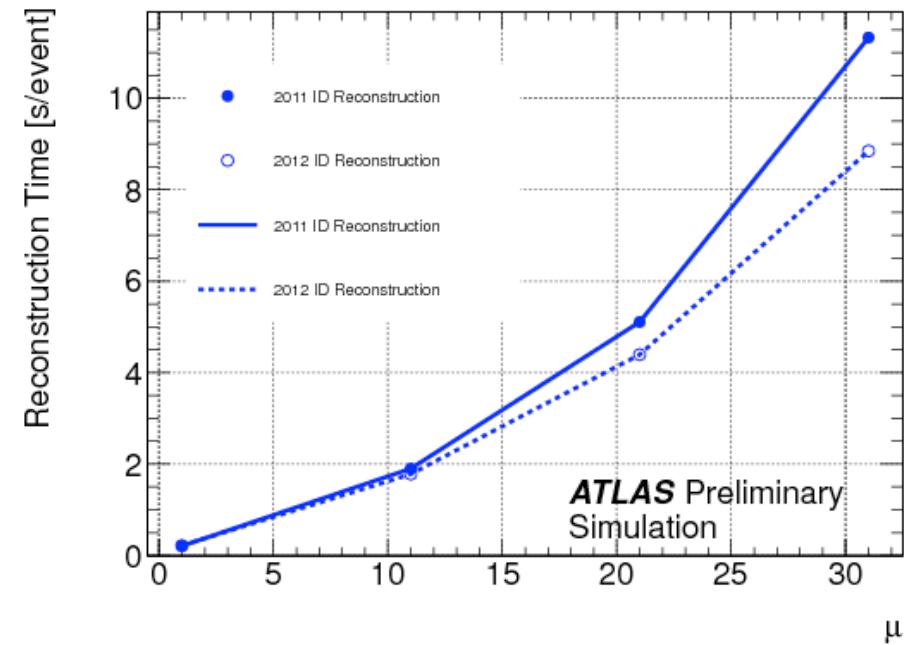
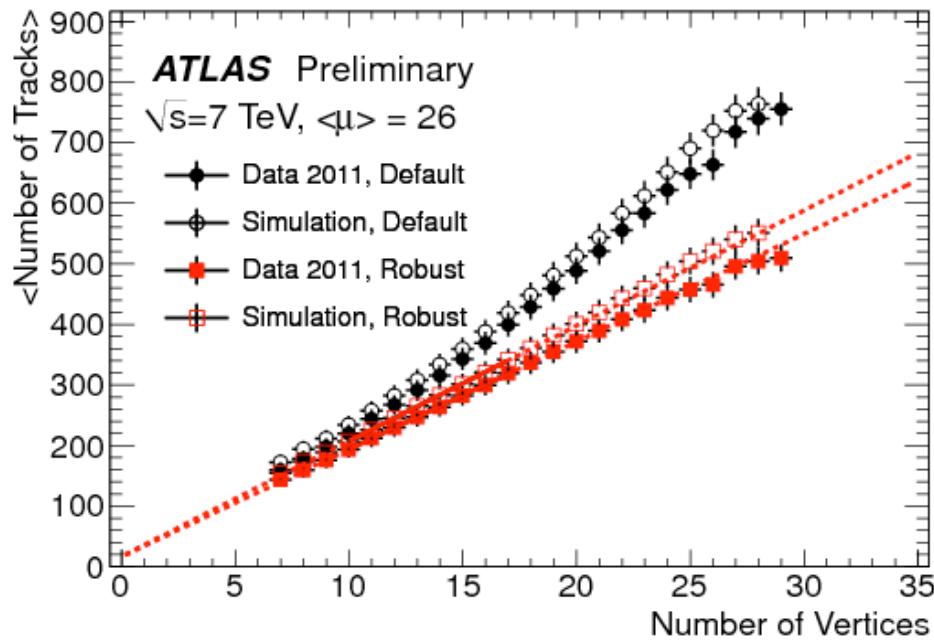
# Element of track finding (pattern recognition)

- Problem:
  - we have many individual measurements
  - which of them come from a particle?
- Local methods
  - Start from seeds build out of a small set of points:
    - enough to provide initial set of track parameters
  - Use the track model to add points and form a track
    - clearly not all seeds will become a track
    - Examples: road method, kalman filter
  - Very flexible, but complexity may increases like  $N^2-N^3$
- Global methods
  - Process all hits at the same time
    - Examples: histogramming method, pattern matching
  - Processing time scales better with N, but, for practical reason:
    - acceptance in parameter space may be restricted
    - not the whole tracker granularity can be exploited

# Seeding in ATLAS



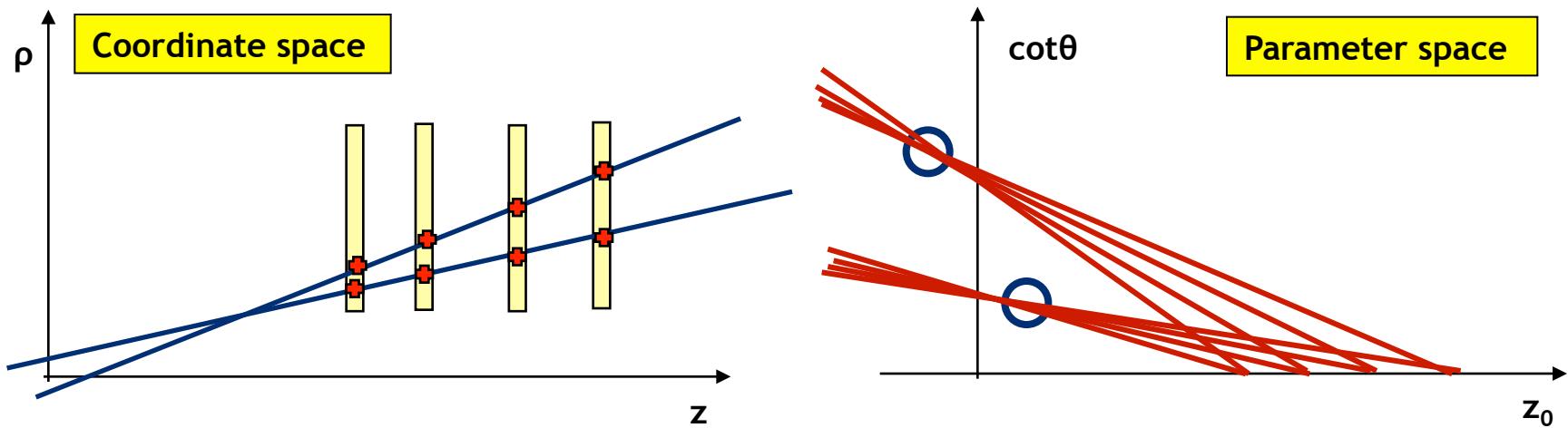
# Dependence on particle density



- Method is sensitive to the detector occupancy (=pile-up)
  - increase of combinatorial background
    - number of reconstructed tracks non linear with number of events: fake tracks
    - can be reduced by tightening acceptance criteria
  - increase of needed CPU resources
    - optimization/parallelization of reconstruction software

# Hough transform

- The Hough transform is a method widely used in image processing.
- It is basically a transform between
  - the coordinate space, in which measurements are performed
  - the parameter space in which tracks are defined
- The track model  $z = z_0 + \rho \cot \vartheta$
- Given a measured point  $(\rho_1, z_1)$ 
  - can be interpreted as a family of trajectories across this point  $\cot \vartheta = \frac{z_1 - z_0}{\rho_1}$



# “Linear” Hough transform

- The above parameterization cannot be directly applied to the transverse plane:
  - it has a singularity for 0/π rad angles
  - there are three parameters
- Let's consider two simplified cases:
  - straight lines  $\kappa=0$ 
    - multiplying first equation for  $-\sin\varphi_0$  and second for  $\cos\varphi_0$ :
$$-\sin\varphi_0 x + y \cos\varphi_0 = d_0$$
      - $\varphi_0$  and  $d_0$  are better behaved parameters;  
one measured point corresponds to a sinusoid in the parameter space.
  - particles coming from the interaction point  $d_0=0$ :
    - trajectory is:  $(x - R \sin\phi_0)^2 + (y + R \cos\phi_0)^2 = R^2$ 
$$x^2 + y^2 - 2xR \sin\phi_0 + 2yR \cos\phi_0 = 0$$
      - using conformal coordinates  $X = 2x / (x^2 + y^2)$   $Y = 2y / (x^2 + y^2)$ 
$$(1/R) - X \sin\phi_0 + Y \cos\phi_0 = 0$$
        - In conformal space circles become straight lines, intercept is the curvature



# Histogramming and “retina” tracking

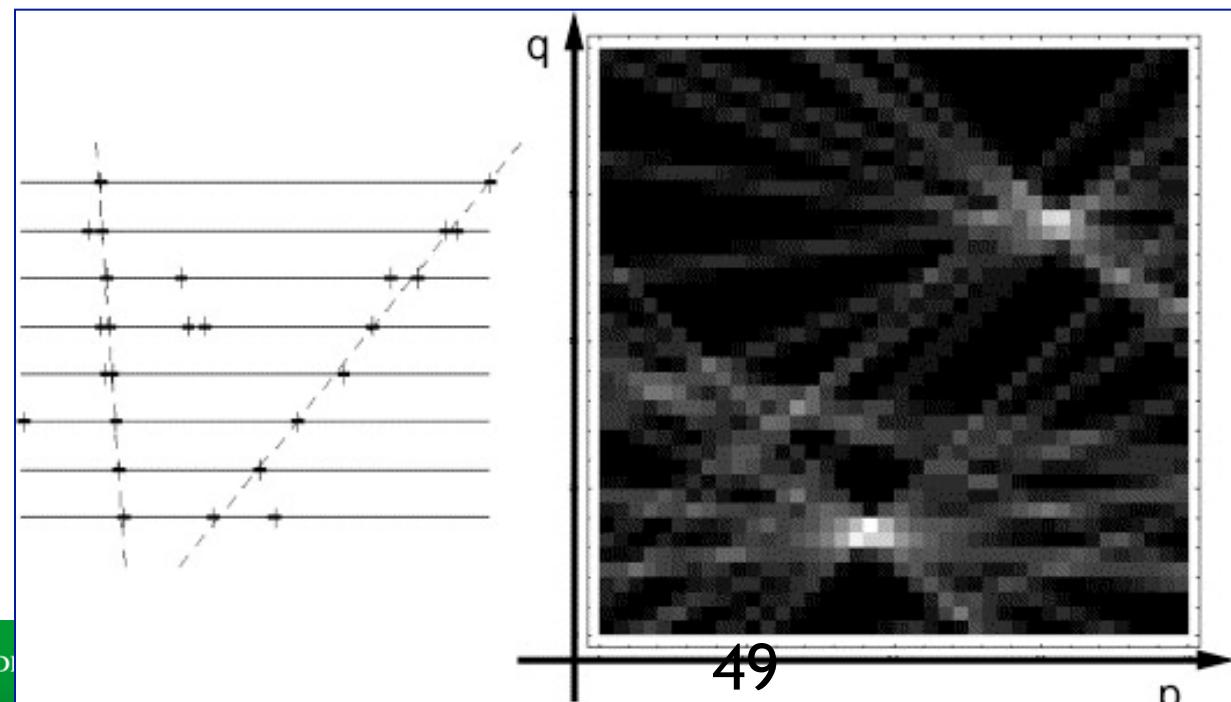
- Histogramming method:
  - partition parameter space ( $p, q$ ) in bins of the possible track parameters
  - fill each bin with a “vote” for each measurement compatible with the parameters
  - look for majorities in the matrices.
- Retina tracking
  - A refinement, inspirated by pattern recognition in the visual cortex.
  - Define a set of neurons excited by shapes,
  - interpolate around local maxima.

$$R_{ij} = \sum_{k,r} \exp\left(-\frac{s_{ijkr}^2}{2\sigma^2}\right)$$

$$s_{ijk} = x_r^{(k)} - y_k(p_i, q_j)$$

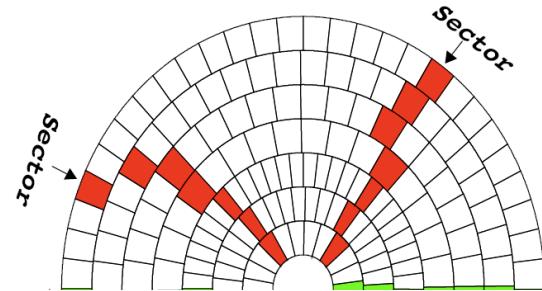
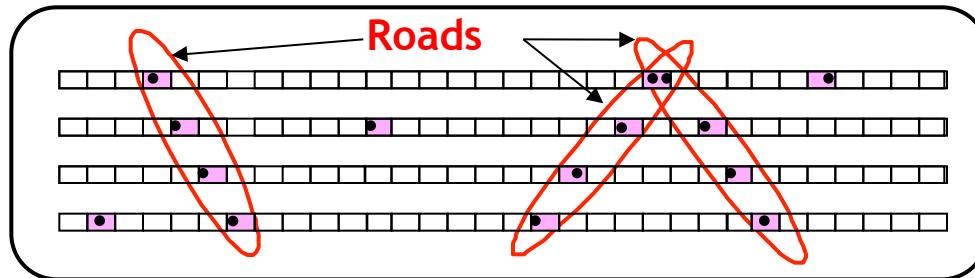
measure  
ment

expectation from  
track model

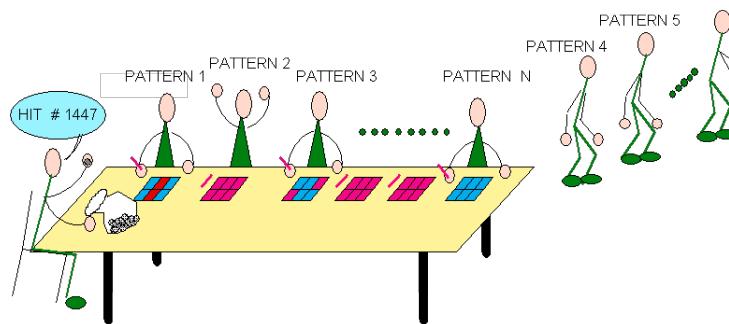
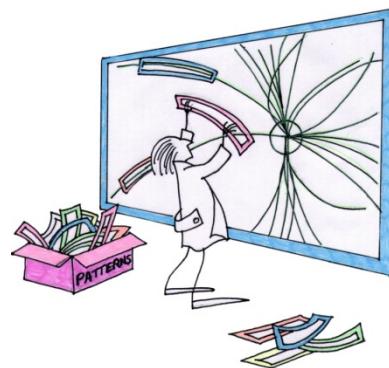


# Pattern matching

- Predefine a set of predefined hit pattern corresponding to a sample of possible trajectories.



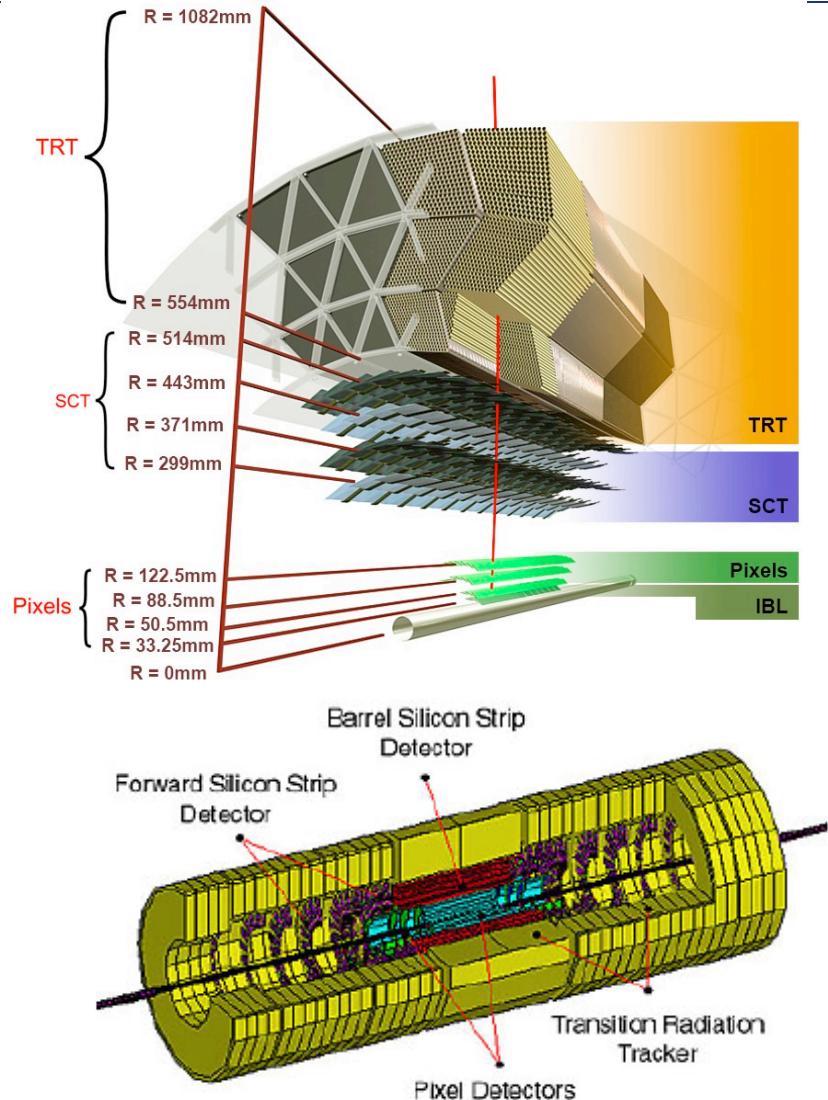
- Find if observed hit match one of the templates



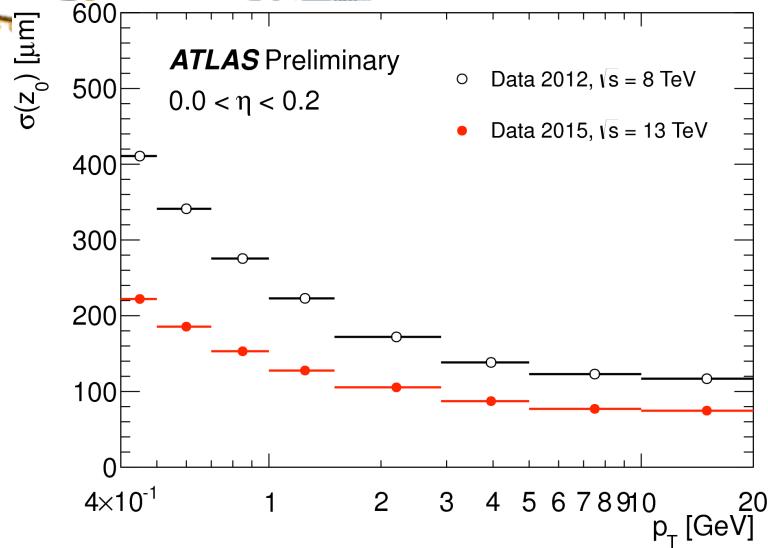
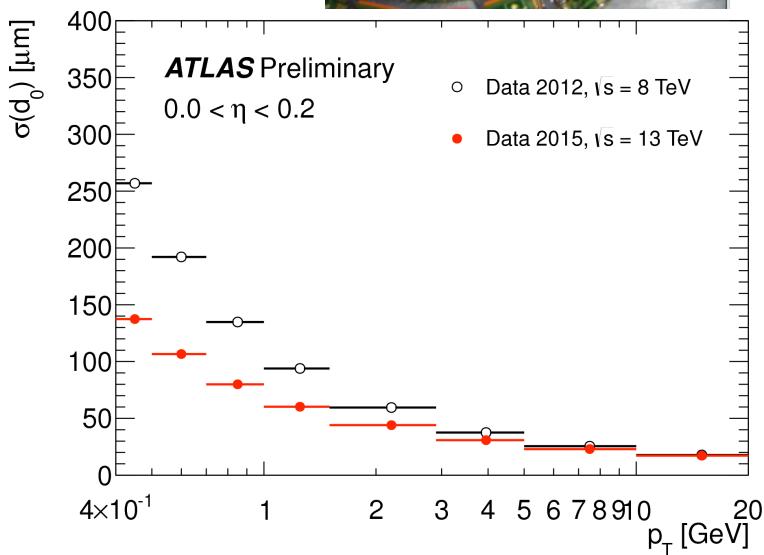
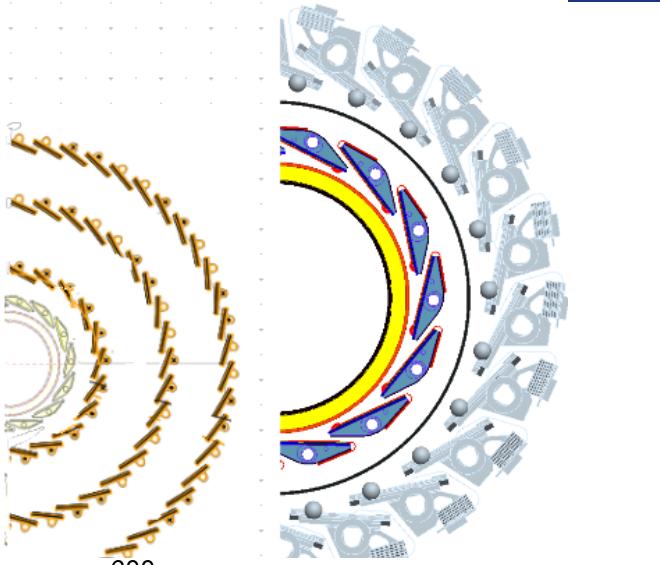
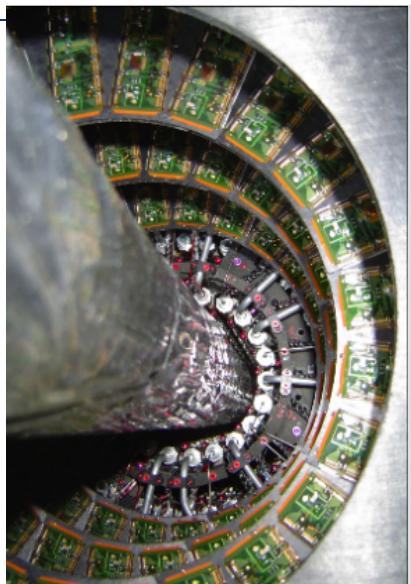
- Fast decision: can be used at trigger level
- Coarse granularity of patterns

# Examples of tracking systems: ATLAS

- Pixel Detector
  - 4 barrel layers, 3+3 disks,  $10^8$  pixels
  - barrel radii: 33, 50, 85, 122 mm
  - pixel size  $50 \times 400 \mu\text{m}^2$  (50 $\times$ 250 IBL)
  - $\sigma_{R\Phi}=6\text{-}10 \mu\text{m}$ ,  $\sigma_z=66 \mu\text{m}$
- SemiConductor Tracker
  - 4 barrel layers, 7+7 disks,  $6 \times 10^6$  strips
  - barrel radii: 30, 37, 44, 51 cm
  - strip pitch 80  $\mu\text{m}$  (40 mrad stereo)
  - $\sigma_{R\Phi}=16 \mu\text{m}$ ,  $\sigma_z=580 \mu\text{m}$
- Transition Radiation Tracker
  - barrel  $55 < R < 102 \text{ cm}$
  - 36 layers, 400000 drift tubes
  - 4 mm diameter
  - $\sigma_{R\Phi}=170 \mu\text{m}$

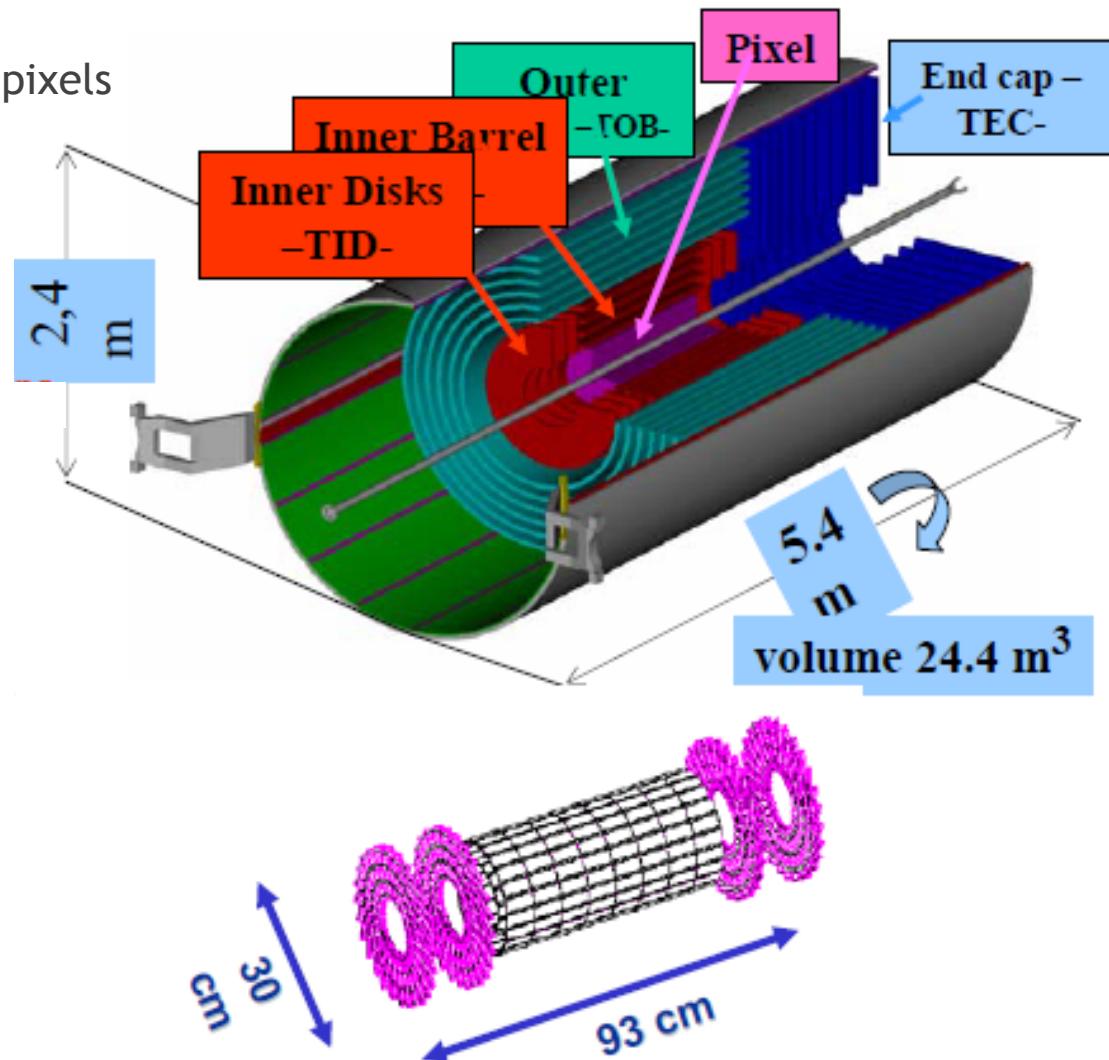


# Examples of tracking systems: ATLAS



# Examples of tracking systems: CMS

- Pixel Detector
  - 2 barrel layers, 2+2 disks,  $10^7$  pixels
  - barrel radii: 41, 100 mm
  - pixel size  $100 \times 150 \mu\text{m}^2$
  - $\sigma_{R\Phi} \sim 10 \mu\text{m}$ ,  $\sigma_z \sim 10 \mu\text{m}$
- Internal Silicon Strip Tracker
  - 4 barrel layers, many disks,  $2 \times 10^6$  strips
  - barrel radii: 20-55 cm
  - strip pitch 80-120  $\mu\text{m}$
  - $\sigma_{R\Phi} \sim 23-35 \mu\text{m}$
- External Silicon Strip Tracker
  - 6 barrel layers, many disks,  $7 \times 10^6$  strips
  - barrel radii: max 116 cm
  - strip pitch 120-180  $\mu\text{m}$
  - $\sigma_{R\Phi} \sim 35-53 \mu\text{m}$

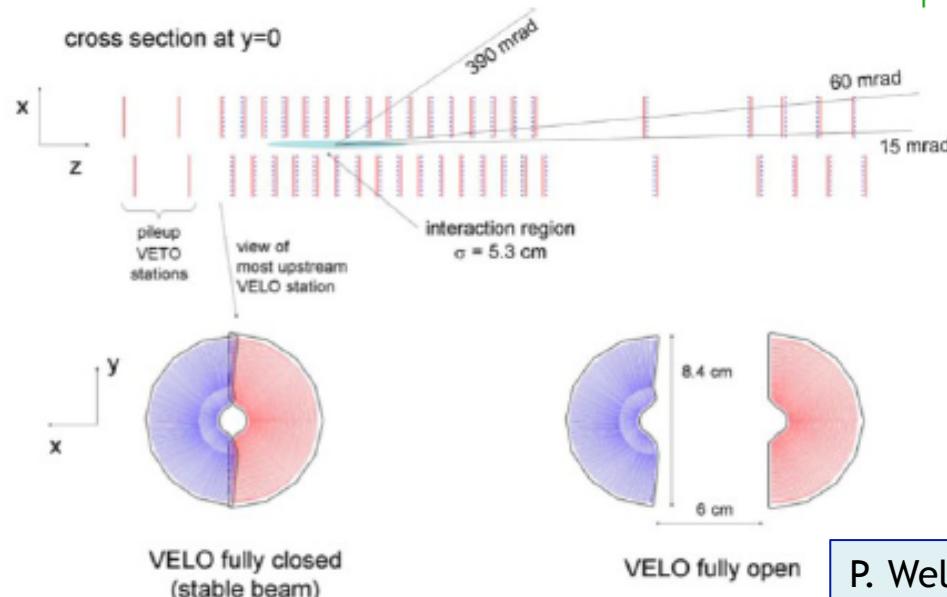


# Examples of tracking systems: vertex detectors

	ALICE	ATLAS	CMS
Radii (mm)	39 – 76	50.5 – 88.5 – 122.5	44 – 73 – 102
Pixel size $r\phi \times z$ ( $\mu\text{m}^2$ )	50 x 425	40 x 400	100 x 150
Thickness ( $\mu\text{m}$ )	200	250	285
Resolution $r\phi / z$	12 / 100	10 / 115	~15-20
Channels (million)	9.8	80.4	66
Area ( $\text{m}^2$ )	0.2	1.8	1

The LHCb VELO: forward geometry strip detector with 42 stations along, inner radius of 7 mm.

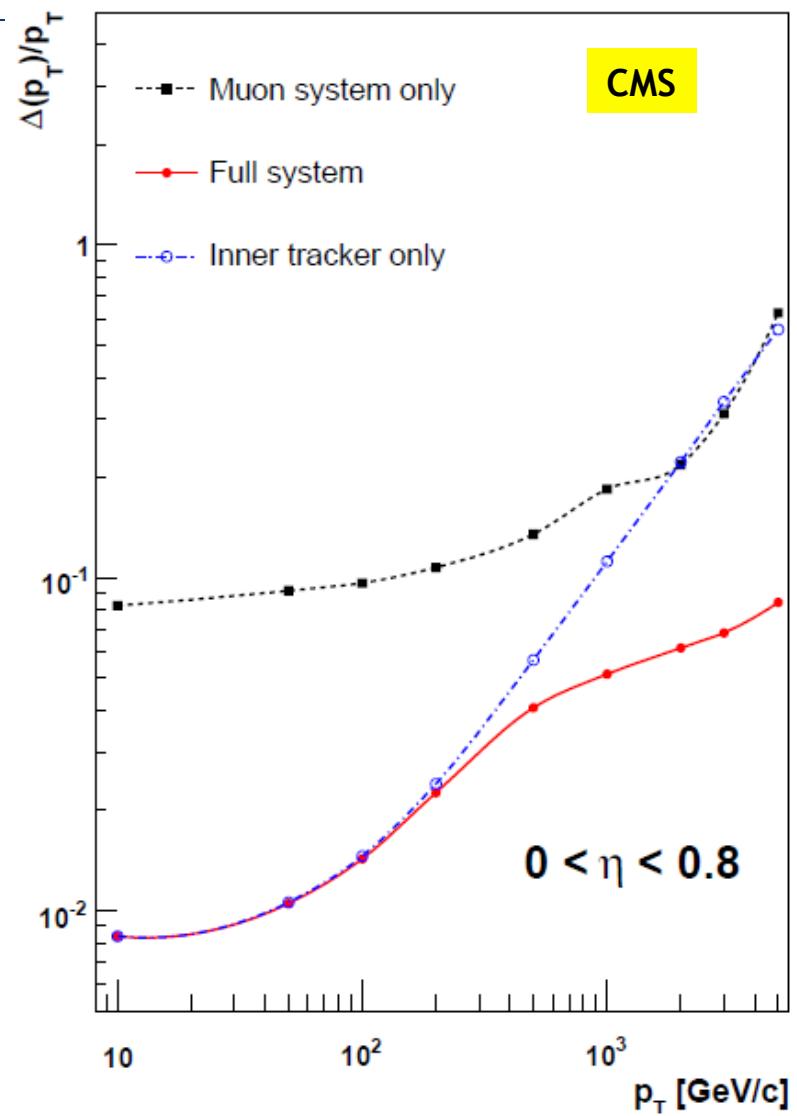
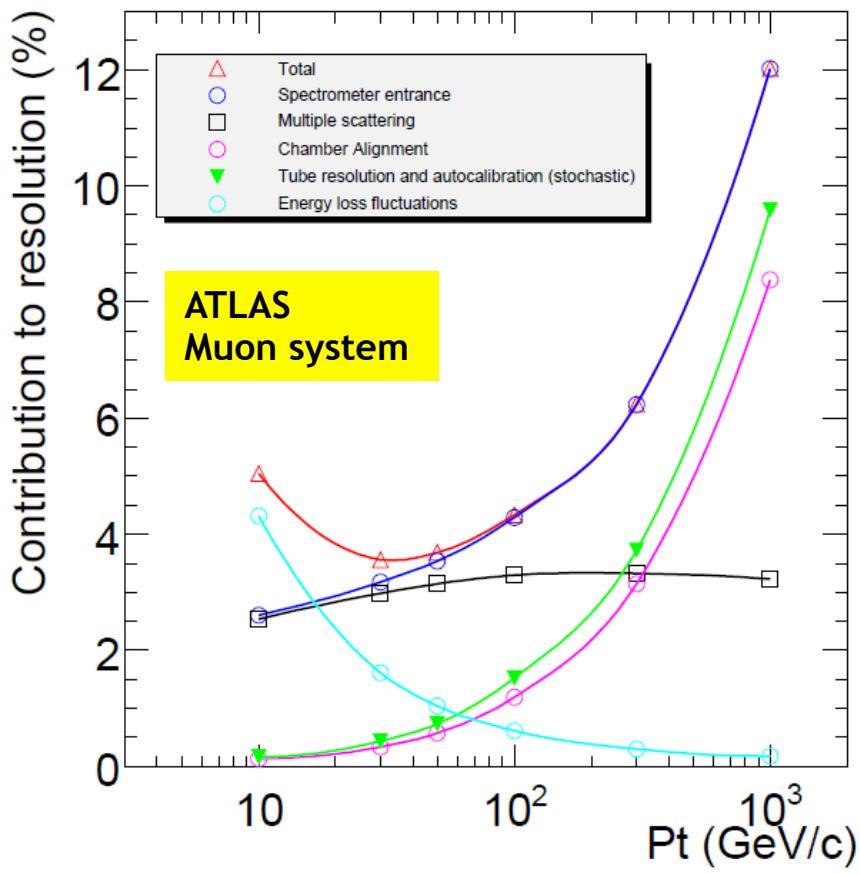
Moves close to beam when it is stable.



5 February 2011

P. Wells, ERDIT 2011

# Examples of tracking systems: momentum resolution

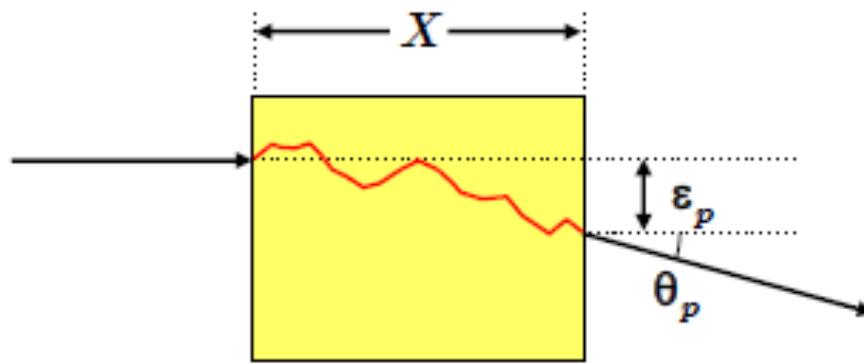


# BACKUP



# Multiple scattering

- Particles moving through the detector material suffer innumerable EM collisions which alter the trajectory in a random fashion (stochastic process)



$$\langle \theta_p^2 \rangle = K \frac{X}{X_0}$$

$$K = z^2 \left( \frac{0.0136}{p\beta} \right)^2$$

$$\langle \varepsilon_p^2 \rangle = \frac{1}{3} K \frac{X}{X_0} X^2$$

strongly correlated

$$\langle \varepsilon_p \theta_p \rangle = \frac{1}{2} K \frac{X}{X_0} X \quad \rho = \frac{\langle \varepsilon_p \theta_p \rangle}{\sqrt{\langle \varepsilon_p^2 \rangle \langle \theta_p^2 \rangle}} = 0.87$$

- Few examples:

- Argon  $X_o = 110 \text{ m}$
- Silicon  $X_o = 9.4 \text{ cm}$
- consider a 10 GeV pion

	$\theta_p$	$\varepsilon_p$
Argon: 1 m	$0.10 \times 10^{-3}$	80 $\mu\text{m}$
Silicon: 300 $\mu\text{m}$	$0.08 \times 10^{-3}$	0.01 $\mu\text{m}$

- The effect goes as  $1/p$ : for a pion of 1 GeV the effect is 10 times larger
- The lateral displacement is proportional to the thickness of the detector: usually can be neglected for thin detectors
- In what follow we will consider only thin detectors
- For thick detectors (for example large volume gas detectors) see [Gluckstern 63 Blum-Rolandi 93, Block et al. 90]